

ISSN 0911-5730
UVSOR-22
March 1995

UVSOR

ACTIVITY REPORT

1994



Ultraviolet Synchrotron Orbital Radiation Facility
Institute for Molecular Science



CONTENTS

Preface

N. Kosugi

Present Status of Light Source and Beam Lines

Status of the UVSOR Accelerator Complex in 1994

H. Hama, T. Kinoshita and J. Yamazaki 1

Beam Lines in 1994

M. Kamada 3

BL1A	Soft X-Ray Beamline for Photoemission - Photoabsorption Spectroscopy
BL1B, 7B	Seya-Namioka Monochromator
BL2B1	Soft X-Ray Beamline for Solids and Solid Surfaces
BL3A1	Irradiation Port with Undulator Radiation
BL3A2	Gas-Phase Dissociative Photoionization Apparatus
BL5B	Calibration Apparatus of Optical Elements
BL6A1	Fourier Transform Far-Infrared Spectroscopy
BL6A2	Photoelectron Spectrometer for Solids and Surfaces
BL6B	Fourier-Transformed Far-Infrared Spectrometer
BL7A	Soft X-ray Spectrometer for Solids
BL8A	Free Port
BL8B1	Photoabsorption and Photoionization Spectrometer
BL8B2	Angle-Resolved UPS System

Research Activities

Linewidth Measurements of the UVSOR Free Electron Laser

K. Kimura, H. Hama, J. Yamazaki, T. Kinoshita and G. Isoyama 19

Design Concept of New Monochromator for Circularly Polarized Synchrotron Radiation in the Energy Range of 5 - 250 eV

M. Kamada, K. Sakai, S. Tanaka, S. Kimura, A. Hiraya, M. Hasumoto, S. Ohara, K. Nakagawa, K. Ichikawa, K. Soda, K. Fukui, Y. Fujii and E. Ishiguro 22

Construction of a New UHV Apparatus for Soft X-Ray Photoemission - Photoabsorption Spectroscopy

Y. Takata, M. Nakamura and N. Kosugi 24

Resonant Ni 3p and 3s Photoemission for the Ni 2p Core-Excitation in NiO

M. Nakamura, Y. Takata and N. Kosugi 26

A Soft X-ray Core-Absorption Study on the Conduction Bands of the Cu and Ag Photodoped Amorphous GeSe₂

S. Hosokawa, T. Kouchi, I. Ono, A. Furuta, M. Taniguchi, Y. Takata and N. Kosugi 28

Polarized Vacuum-UV Absorption and Reflection Spectra of Poly (tetrafluoroethylene) and Its Model Compound K. Nakagawa, T. Miyamae, R. Mitsumoto, H. Ishii, Y. Ouchi and K. Seki	30
Two Types of STE Luminescence in PbCl ₂ Crystal M. Kitaura, H. Nakagawa, K. Fukui, M. Fujita and T. Miyanaga	32
Photoionization Potentials of Fullerenes (C ₆₀ ~ C ₈₄) in Nonpolar Liquid I. Shimoyama, K. Nakagawa, C. Fujikawa, K. Morii, T. Mitani and R. Katoh	34
Emission and Excitation Spectra of (C _n H _{2n+1} NH ₃) ₂ CdCl ₄ : n=1, 2, 3 A. Ohnishi, T. Yamada, T. Yoshinari, K. Kan'no, I. Akimoto and T. Kamikawa	36
Photoyield Measurements of CVD Diamond N. Eimori, A. Hatta, T. Ito and A. Hiraki	38
Impurity-Induced Quenching of Auger-Free Luminescence in Mixed CsCl _{1-x} I _x System M. Itoh, H. Hara, N. Ohno, H. Yoshida, K. Kan'no and S. Hashimoto	40
Recombination Luminescence from Self-Trapped Excitons in BaFCl A. Ohnishi, K. Kan'no, Y. Iwabuchi and N. Mori	42
A Fast Decay Component of the BG-Emission in KCl:I M. Abe, T. Matsumoto and K. Kan'no	44
Photo-Luminescence in Alkali Earth Fluorides A. Ejiri, A. Hatano and K. Nakagawa	46
Relaxation Dynamics of Free Excitons in Alkali Iodides T. Hayashi, T. Tsujibayashi and M. Watanabe	48
Silicon Precipitation in Surface Layers of Amorphous Si ₃ N ₄ Films with ArF Excimer Laser Irradiation K. Nakamae, K. Kurosawa and R. Sonouchi	50
Photochemistry of Cyanogen Bromide in the 40 - 120 nm Region K. Kanda, T. Nagata, M. Kono, A. Hiraya and K. Shobatake	52
Photoabsorption and Fluorescence Cross Sections of SiCl ₄ in the 40 - 120 nm Region T. Ibuki, M. Kono and K. Shobatake	54
Absorption and Fluorescence Studies of CCl ₃ CN in the Vacuum Ultraviolet Region K. Tabayashi, Y. Shimomura, M. Akao, K. Saito, M. Kono, H. Ohashi and K. Shobatake	56

VUV Absorption and $CN(B^2\Sigma_g^+)$ Excitation Spectra of Chlorinated Acetonitriles M. Akao, K. Tabayashi, Y. Shimomura, K. Saito, M. Kono, H. Ohashi and K. Shobatake	58
Photodissociation Dynamics of HNCO Studied by Photofragment Fluorescence Polarization Measurements Y. Matsushita, Y. Hikosaka, M. Kono, K. Shobatake and T. Hikida	60
Core Electron Absorption Spectra of Undrawn and Drawn Polyester Films I. Ouchi, I. Nakai, M. Kamada, S. Tanaka and T. Hagiwara	62
$3p \rightarrow 3d$ Resonant Photoemission Spectra of $LaTO_3$ (T=Co, Ni) Y. Taguchi, M. Kageyama, K. Soda, T. Katsumi, S. Tanaka, K. Ishikawa, Wu Qing, K. Okuda and O. Aita	64
Orientation and Disorption of Oxygen Admolecules on a Pt (113) Stepped Surface T. Yamanaka, T. Matsushima, S. Tanaka and M. Kamada	66
NEXAFS Study on the Absorption Structure of N_2O on Si (100) (2×1) Surface K. Sawabe and Y. Matsumoto	68
The Studies on the Core-Excitonic Effect of Aromatic Hydrocarbons in NEXAFS Spectroscopy H. Oji, R. Mitsumoto, E. Ito, H. Ishii, Y. Ouchi, K. Seki and N. Kosugi	70
Photoemission Studies on Valence Band Structure of $AgSbO_3$ M. Yasukawa, H. Hosono, N. Ueda and H. Kawazoe	72
Photoemission Study of $TlAlF_4$ H. Mizoguchi, T. Omata, H. Hosono, N. Ueda and H. Kawazoe	74
Surface Core Exciton of Alkali Chloride Film on Si (100) S. Tanaka, N. Takahashi, M. Kamada and K. P. Lee	76
Annealing Effect of NaCl Film on Si (100) Surface S. Tanaka, M. Kamada and K. P. Lee	78
Observation of Doubly Excited Rydberg States of CO_2 by Positive Ion - Negative Ion Coincidence Spectroscopy H. Yoshida and K. Mitsuke	80
Photodarkening Phenomena in Amorphous Chalcogenide Films K. Hayashi, D. Kato and K. Shimakawa	82
Preparation of ZnO Thin Films from DEZn at Various Temperatures Using undulator Radiation (UR) - Excited CVD A. Ganjoo, S. Ikeda, K. Maeda and A. Yoshida	84

Time Reponse of Excited-State Na Desorption from NaCl (Temperature Dependence) S. Hirose and M. Kamada	86
Observation and Investigation of Solid C ₆₀ F ₄₈ and C ₇₀ F ₅₈ Luminescence A. Kolmakov, V. Stankevitch, V. Bezmelnitsin, A. Rizkov, V. Sokolov, N. Svechnikov, I. Akimoto, T. Matsumoto, K. Kan'no, S. Hirose and M. Kamada	88
Radiative Transitions in C ₆₀ Thin Films under SR Excitation M. A. Telekhin, N. Yu. Svechinikov, M. Kamada, K. Kan'no, V. G. Stankevitch, A. A. Kolmakov, V. A. Stepanov, V. N. Bezmelnitsin, T. Matsumoto, I. Akimoto, A. Ohnishi and M. Ashida	90
Dissociative Photoionization of Iron Pentacarbonyl in the Range 30 - 120 eV. I. Observation of New Molecular Dications and C-O Bond Rupture in the Ligand Y. Tamenori and I. Koyano	92
Dissociative Photoionization on Iron Pentacarbonyl in the Range 30 - 120 eV. II. A Photoion - Photoion Coincidence Study of the Dissociation of Doubly and Triply Charged Parent Ions Y. Tamenori and I. Koyano	94
Dissociative Single and Double Photoionization of CS ₂ T. Masuoka	96
Kinetic-Energy Release in the Dissociation of SO ₂ ²⁺ T. Masuoka	98
Kinetic-Energy Release in the Dissociation of CO ₂ ²⁺ T. Masuoka, E. Nakamura and A. Hiraya	100
Single- and Double-Photoionization Cross Sections of Carbon Dioxide (CO ₂) and Ionic Fragmentation of CO ₂ ⁺ and CO ₂ ²⁺ T. Masuoka	102
Photodissociation of CF ₃ Br Induced by Br (3d) Excitation T. Senga, M. Kawasaki, A. Hiraya and T. Ibuki	104
Development of a Position-Sensitive Detection System for VUV Photoelectron Spectroscopy K. Mitsuke, Y. Hikosaka, H. Hattori and T. Hikida	106
Two-Dimentional Photoelectron Spectroscopy of NO Y. Hikosaka, H. Hattori, T. Hikida and K. Mitsuke	108
Autoionization of an Excited Valence State of C ₂ H ₂ H. Hattori and K. Mitsuke	110

Synchrotron Radiation Photochemistry in Low-Temperature Condensed Layers of Organo-Aluminium Compounds on SiO ₂ Surface Investigated by Buried-Metal-Layer Infrared Reflection Absorption Spectroscopy Y. Imaizumi, Y. Tsusaka and T. Urisu	112
Synchrotron Radiation Excited Growth of ZnTe by Atomic Layer Epitaxial Technique Using Metalorganic Sources T. Ogata, S. I. Gheyas, H. Ogawa and M. Nishio	114
Synchrotron Radiation Assisted Surface Process of Adsorbed Diethylzinc on GaAs (100) S. I. Gheyas, T. Ogata, H. Ogawa and M. Nishio	116
Low Temperature Growth of II-VI Compound Semiconductors by Synchrotron Radiation Using Metalorganic Sources T. Ogata, S. I. Gheyas, H. Ogawa and M. Nishio	118
In Situ Observation of SR-Induced a-Si Deposition by Using BML-IRAS A. Yoshigoe, M. Nagasono, K. Mase and T. Urisu	120
Synchrotron Radiation Excited Etching of Silicon Surface Studied by Velocity Distribution Measurements of Desorbed Species (III) H. Ohashi and K. Shobatake	122
Beamsplitting and Polarization Properties of Cr/C Transmission Multilayers Close to the Carbon K-Edge F. Schäfers, A. Furuzawa, K. Yamashita, M. Watanabe and J. H. Underwood	124
Optical Properties of Compound Semiconductors in VUV Region Q. Guo, Y. Mitsuishi, H. Ogawa and A. Yoshida	126
VUV Reflection Spectra of Amorphous Chalcogenide Films K. Hayashi, D. Kato and K. Shimakawa	128
Characterization of Normal Incidence Multilayer Telescope in 100 - 300 Å Region K. Yamashita, H. Kunieda, T. Yamazaki, K. Ikeda, K. Misaki, Y. Takizawa, M. Nakamura and I. Yoshikawa	130
Angular Distribution of Ne Metastable Desorption Induced by Exciton Formation at the Surface of Solid Ne T. Hirayama, T. Nagai, M. Abo, I. Arakawa, M. Sakurai and K. Mitsuke	132
VUV Reflectivity Spectra of Rare-Earth Sesquioxides IV F. Arai, S. Kimura, M. Ikezawa and M. Ishigame	134
Far Infrared Absorption of Ice XI M. Kobayashi and D. Tazawa	136

Size-Dependence of Phase Transition of CdS Microcrystals T. Nanba, Y. Notake and G. P. Williams	138
Multichannel FT Spectrometer for Mid-Infrared S. Asaka and J. S. Ahn	140
Far Infrared Transmission of SmTe under High Pressure Y. S. Kwon, T. S. Park, K. S. An, I. S. Jeon, S. Kimura, C. Y. Park, T. Nanba and T. Suzuki	141
Infrared Low Frequency Study of the Phase Transitions in LiKSO ₄ and LiNaSO ₄ Single Crystals F. Rull Perez and S. Kimura	142
Optical Observation of Interaction between Low Frequency Plasma and Magnetic Field in La _{2-x} Sr _x CuO ₄ (x≈0.1) S. Kimura, M. Ikezawa, H. Kojima, I. Tanaka, T. Watanabe and M. Tachiki	144
Far-Infrared and Millimeter Wave Spectra of Superionic Glasses of AgI-AgPO ₃ T. Awano and T. Nanba	146
Photoemission Study of the Al-Pd-Mn F1-Type Icosahedral Phase M. Mori, M. Kamada, T. Miyazaki and T. Ishimasa	148
Decay Curves for Auger-Free Luminescence from BaF ₂ Excited near the Ba 4d Edges S. Kubota, M. Kamada and M. A. Terekhin	150
Electron Spectroscopy of Stage 2 FeCl ₃ -Graphite Intercalation Compound T. Abe, Y. Mizutani, E. Ihara, M. Asano, T. Harada, M. Kawase, S. Nakanishi, H. Itoh and M. Kamada	152
Metallic Na Formation in NaCl Crystals by Electron and VUV Photon Irradiation S. Owaki, S. Koyama, M. Takahashi and M. Kamada	154
Photon-Energy Dependence of Excited-State Na Desorption from Na Halides S. Hirose and M. Kamada	156
Photoemission Study of Iodine Nitride K. Fukui and M. Kamada	158
Resonant Photoemission of R ₃ Au ₃ Sb ₄ (R = La, Ce and Pr) S. Kimura, M. Kamada, K. Katoh and M. Kasaya	160
Far-Infrared Reflectance of β''-(BEDT-TTF) ₂ AuBr ₂ : Coexistence of Free Carriers and a Single-Particle Gap at 2Δ = 130 cm ⁻¹ A. Ugawa, D. B. Tanner and K. Yakushi	162

Mo L _{III} -Edge and Mg K-Edge XANES Study of Local Structure of MoO ₃ -MgO Binary Oxide H. Aritani, T. Tanaka, T. Funabiki, S. Yoshida and S. Hasegawa	164
A XANES Study on the Dehydration Process of Magnesium Hydroxide T. Yoshida, Y. Tanaka, H. Yoshida, T. Funabiki, S. Yoshida and T. Murata	166
Nd L-Edge XANES Study of Nb Compound Catalysts Y. Nishino, M. Aida, S. Matsuhara, K. Nakamura and S. Hasegawa	168
Throughput at BL7A Using Wiggler Operated at 2 T and 4 T M. Watanabe and O. Matsudo	170
Na K XANES Spectra of Silicate Crystals and Glasses T. Murata, S. Hayashi and G. E. Brown Jr.	172
S-K and P-K Polarized Absorption Spectra of Layered Thiophosphates MPS ₃ (M=Mn, Fe, Ni, Zn, Mg) A. Kamata, S. Nakai, T. Kashiwakura, N. Kozuka, T. Yokohama, H. Tezuka and O. Matsudo	174
VUV Reflection Spectra of Electrically Polarized TiO ₂ -Containing Silicate Glass with Optical Second Harmonic Generation Activity K. Kurachi, J. Matsuoka, H. Nasu and K. Kamiya	176
Optical Characteristics of Fluorine -Doped SiO ₂ Formed by Plasma-Enhanced Chemical Vapor Deposition K. Ishii and Y. Ohki	178
Reflection Spectra of Nonequilibrium Solid Solutions in Alkali Bromides S. Hashimoto and M. Inaba	180
Dispersion Properties of Excitons in Thin Alkali Bromide Crystals N. Ohno, I. Iwaki, S. Hashimoto and M. Itoh	182
VUV Reflection Spectra of LiF Doped Fluoroaluminate Glasses N. Kitamura, K. Fukumi, K. Kadono and H. Yamashita	184
Crystallization Processes of Amorphous CdI ₂ Thin Films K. Fukui, K. Niimi, T. Yamada and H. Nakagawa	186
Time-Resolved Tryptophan Fluorescence of Glycerinated Muscle Fibers M. Taniguchi and I. Yoda	188
SOR Patterning of Plasma Polymerized HMDS Resist with 0.2 Micron Mask S. Morita, G. K. Vinogradov, Y. Koval, C. Shao, R. Inanami and K. Senda	190

SiC Nucleation on Si Substrate for Diamond Formation Using Synchrotron Radiation Enhanced Chemical Vapor Deposition Employing Methanol and H Radical M. Ikeda, M. Hori, T. Goto, M. Inayoshi, M. Hiramatsu, M. Nawata and A. Hiraya	192
Soft X-Ray Microscope with Zone Plate at UVSOR N. Watanabe, S. Aoki, Y. Shimanuki, K. Kawasaki, M. Taniguchi, E. Anderson, D. Attwood, D. Kern, S. Shimizu, H. Nagata, Y. Horikawa, S. Mochimaru and H. Kihara	194
Accumulated Photon Echoes in UV by Using Dispersion Compensation H. Itoh, S. Nakanishi, M. Kawase, H. Fukuda, N. Tsurumachi, H. Inoue, H. Nakatsuka and M. Kamada	196
Performance Test of Constant-Deviation Constant-Length Spherical Grating Monochromator at BL8B1 A. Hiraya, E. Nakamura, J. Adachi, M. Hasumoto, T. Kinoshita, K. Sakai, E. Ishiguro and M. Watanabe	198
The Electronic Structure of Porphyrin / Metal Interfaces Studied by Ultraviolet Photoelectron Spectroscopy D. Yoshimura, S. Narioka, M. Sei, H. Ishii, Y. Ouchi, T. Miyazaki, S. Hasegawa, Y. Harima, K. Yamashita and K. Seki	200
Determination of Azimuthal Orientation of Metal-Free Phthalocyanine on MoS ₂ Surface K. Kamiya, M. Momose, Y. Harada, N. Ueno, T. Miyazaki, S. Hasegawa, H. Inokuchi, S. Narioka, H. Ishii and K. Seki	202
UPS Study of NiPS ₃ and FePS ₃ Crystals by Using Synchrotron Radiation T. Miyazaki, H. Inokuchi, S. Hasegawa, K. P. Lee, K. Ichimura and H. Fujimoto	204
Photoemission Study on Poly (pyridine - 2, 5 - diyl), Poly (2, 2' - bipyridine - 5, 5' - diyl), and their K-doped States T. Miyamae, D. Yoshimura, H. Ishii, Y. Ouchi, T. Miyazaki, T. Koike, T. Yamamoto and K. Seki	206
Synchrotron - Radiation Photoemission Study of <i>in-situ</i> Synthesized DCNQI (N, N' - Dicyanoquinonediimine) - Cu Salts A. Tanaka, A. Chainani, T. Miura, T. Takahashi, T. Miyazaki, S. Hasegawa and T. Mori	208
Ultraviolet Photoelectron Spectra of C ₇₈ and C ₉₆ S. Hino, H. Takahashi, K. Iwasaki, T. Miyazaki, K. Kikuchi and Y. Achiba	210

Appendix

Organization	213
Joint Studies	214
List of Representative of Cooperative Research	215
Program of UVSOR Workshop on Present Status and Future Plans of VUV Beam Lines for Solid-State Research	217
List of Publications	219
Ground Plan of the UVSOR Facility	225
Accerlator Complex and Intensity Distribution	226
Beam lines at UVSOR	229
Location	230



PREFACE

This is the Activity Report for 1994 reporting the research activities at the UVSOR facility. The number of users are still increasing, and we are improving the performance of the light source and beamlines. Professor Volker Saile, Director of CAMD of the Louisiana State University, and Professors Takehiko Ishii and Motohiro Kihara, Directors of SOR-RING(SRL-ISSP) and Photon Factory, were invited in order to evaluate the research activities of UVSOR in November 1993 and in August 1994. Professor Saile's report is summarized as follows:

1. A clear mission statement and strategic planning are required to maintain highest standards and competitiveness in the future. The recommended mission is "Synchrotron Radiation Research and Applications in Chemistry." Support with highest priority is recommended for the strongest programs in chemistry research: "Photo-assisted Chemical and Surface Reactions", "Chemical Spectroscopies in the VUV and soft X-ray range", "Infrared Applications of Synchrotron Radiation", and "Molecular Crystals and Films."
2. Continuous minor and major improvements of the accelerator system are required.
3. An evaluation of number and performance of beamlines is recommended. Consider to reduce the number of beamlines and develop new highly competitive instruments, e.g., a high resolution soft x-ray monochromator. A sufficient number of competent staff is required to rearrange UVSOR's beamlines.

Professors Ishii and Kihara reached almost the same conclusions. We are very grateful to them for encouraging us to improve and enhance the accelerator system and the beamlines. Some of the improvements are reported in this issue.

As reported in the last issue Dr. Makoto Watanabe moved to the Tohoku University in October 1993, and furthermore Dr. Goro Isoyama moved as a full professor to the Osaka University in March 1994. The UVSOR has only three chairs for the associate professor. Two of them were unoccupied at the beginning of FY94. Very recently we could have new associate professors, Toyohiko Kinoshita and Hiroyuki Hama. Dr. Kinoshita came from the SOR-RING(SRL-ISSP) of the University of Tokyo in October 1994 and is actively working as a main member of the beamline staff together with Dr. Masao Kamada. Dr. Hama was promoted from a research associate of UVSOR in January 1995 and continues to work as a chief in accelerator physics.

The facility has reached its limit of capacity. We have started to discuss the next 10 years. The FY95 will be an important year for UVSOR.

February 1995



Nobuhiro Kosugi
Director of UVSOR



EDITORS

Shin-ichi KIMURA

<kimura@ims.ac.jp>

Masao KAMADA

<kamada@ims.ac.jp>

The mark of UVSOR



was designed by Prof. H. Hama.

ACKNOWLEDGMENTS

The editors would like to thank Ms. Hisayo Hagiwara, staffs and beam line masters of UVSOR facility for their help in editing this issue.



UVSOR members and in-house users.



Present Status of
Light Source and Beam Lines

Status of the UVSOR Accelerator Complex in 1994

Hiroyuki HAMA, Toshio KINOSHITA and Jun-ichiro YAMAZAKI

UVSOR Facility, Institute for Molecular Science, Okazaki 444 Japan

In 1994, the UVSOR storage ring and its accelerator complex were operated for almost a whole year except some minor unexpected shutdowns and two-week shutdown terms for hardware maintenance in Spring and Summer. Scheduled beam time was properly consumed as shown in Fig. 1. In Spring shutdown term, a new power supplier for the deflector magnet in the synchrotron replaced the old one. Severe drift of output current from the old power supplier had disturbed stable beam injection for long time. Both control systems of the deflector and the fast kicker were also improved by connecting with the CAMAC highway of the computer control system, and extraction of the accelerated beam is now very stabilized with the new power supplier and the control system.

Progress in operation of the superconducting 4T wiggler has been under way since it was installed. The wiggler operation has become into routine operation because a hardware trouble concerning a helium leakage was almost fixed. The operation time of the wiggler in multi-bunch mode increased by 10 % of whole beam time over the last year. The beam orbit with the wiggler operation has been also improved by a computer code of multi-dimensional iterative optimization method that is linked with a control system "UCOSS".

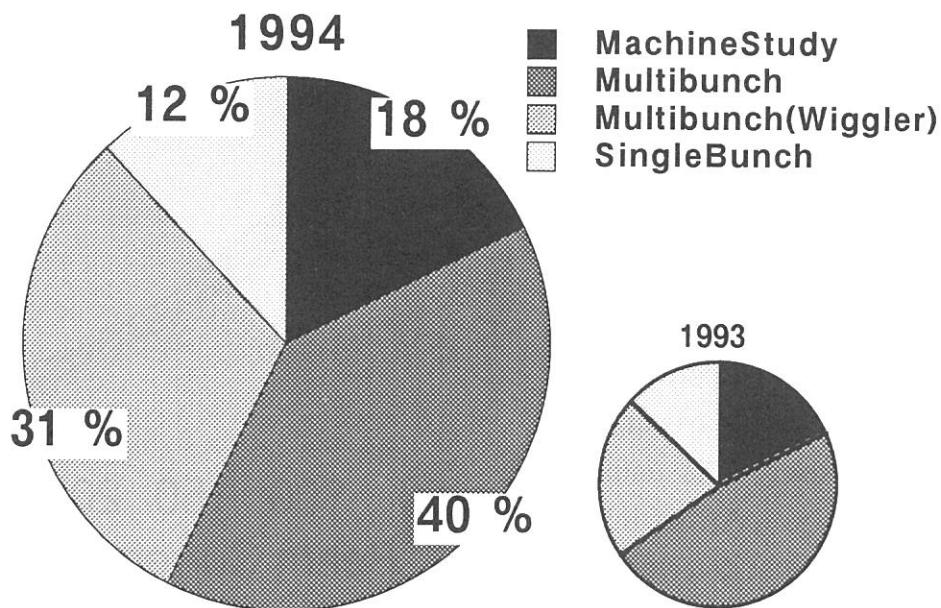


Fig. 1 Machine time consumption in 1994. Summarized a term from January to December.

Because of ambiguity of the ring parameters, the orbit correction has not been completed yet. This method is, however, a quite powerful tool (see Fig. 2), so that correction for the wiggler operations with low magnetic fields (2 T or 1.5 T) will be hopefully achieved.

The double-cavity rf system has been used in the whole beam time even single-bunch mode. Although there was a trouble in operation of the harmonic cavity due to the beam-induced field, the beam has become stable by changing the operation method after the machine study in April. Typical beam lifetime in multi-bunch mode is 4 hours

at 200 mA and 8 hours at 100 mA as shown in Fig. 3. It should be noted that a partial filling technique is normally used to suppress an effect of ion-trapping (among 16 buckets, 13 buckets are filled), therefore stored current in one bucket is relatively higher than previous operation, and the vertical beam size is almost same as that in single-bunch mode. Because control of the harmonic cavity has been manually operated, a suitable control software is necessary and now under developing.

We experienced serious hardware failures for the inflector and a control system of the synchrotron. It was concluded that both cases were caused by deterioration of electric devices, i.e., condensers and ICs. Since such parts are for specific purposes, it is usually difficult to fix. An efficient counterplan against deterioration is highly desired.

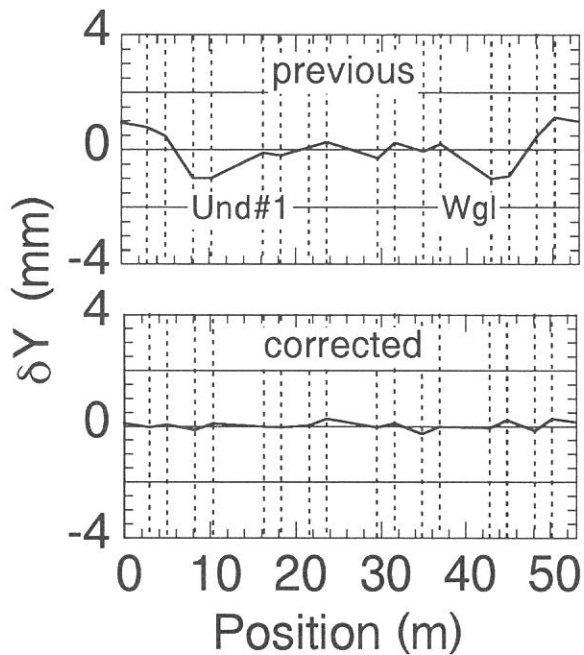


Fig. 2 Beam orbit correction (vertical) for the 4 T wiggler operation.

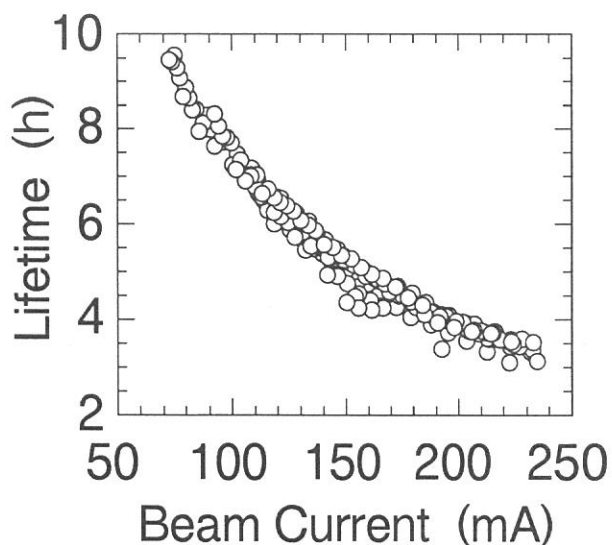


Fig. 3 Beam lifetime in multi-bunch mode plotted as a function of the beam current. Data were taken for a week in December.

Beam Lines in 1994

Masao Kamada

UVSOR Facility, Institute for Molecular Science

In 1994, eighteen beam lines were operational. The open beam lines (1B, 2B1, 3A1, 3A2, 5B, 6A1, 7A, 7B, and 8A) were used by 126 outside groups, while the in-house beam lines (1A, 2A, 2B2, 3B, 4A, 4B, 6A2, 6B, and 8B2) were used by the groups in IMS as well as 28 outside collaborating groups. The beam times used in 1994 are listed in the following tables (in Japanese).

Besides them, a 15-m Constant Deviation Monochromator covering the spectral range of 30-600 eV is now ready for gas-phase and solid-state experiments at beam line 8B1. Another new monochromator (SGM-TRAIN) which is a combination of the improved version of the constant deviation monochromator and the normal incidence monochromator is under construction at beam line 5A.

The UVSOR facility is opened to all researchers from universities and government research-institutes. Beam times are available for the private companies with the payment of the beam-time fee. Foreign researchers can use the beam time in the collaboration with Japanese researchers. In 1994, many foreign researchers visited the UVSOR facility to carry out their experiments at 2B1, 3A1, 5B, 6A1, and 6A2.

The station master system introduced three years ago to support systematically a variety of experiments will be continued for future with a slight change in the member list. All users for open beam lines(*) are requested to contact with the following station masters and/or the supervisors to discuss the action plans of the experiments in details.

Beam Line	Station Master	Sub Master	Supervisor
1B	M. Hasumoto	S. Tanaka	M. Kamada
2B1	S. Tanaka	E. Nakamura	M. Kamada
3A1	M. Kamada	A. Hiraya	M. Kamada
3A2	E. Nakamura	A. Hiraya	T. Kinoshita
5B	S. Kimura	M. Hasumoto	T. Kinoshita
6A1	O. Matsudo	S. Kimura	M. Kamada
7A	O. Matsudo	T. Kinoshita	T. Kinoshita
7B	T. Kinoshita	M. Hasumoto	T. Kinoshita
8A	K. Sakai	T. Kinoshita	T. Kinoshita
8B1	A. Hiraya	E. Nakamura	T. Kinoshita

*The persons who wish to use the in-house beam lines are recommended to contact with the representative of each beam line, which is listed in the Appendix of the UVSOR Activity Report.

The open beam lines

	3/28	4/4	4/11	4/18	4/25	5/2	5/9	5/16	5/23	5/30	6/6	6/13	6/20	6/27	7/4	7/11	7/18	7/25	8/1	8/8	8/15	8/22	8/29	9/5	9/12	9/19	9/26												
1 B	中	川英	平	木				中	川和	関	整備	伊	藤	太	田	藤	田	江尻	林				林	黒	沢	整備	神	野											
2B1	田中	松	木					田	中		細	野	田	中			大内	幸	松	川				小	林光		大内	伊											
3A1	鎌田	林						林			鎌	田					吉	田						宮永	西	尾		宮永											
3A2		(平	谷)							増	岡	(坂	岡)					伊	吹					増	岡	小	谷	野											
5 B		山	下	石黒	(林)			荒	川		林		木	村	井	上	見	附	林				岡	野	山	下	小	川	岡	野									
6A1		木	村						難	波			小	林	整備	浅	香		鈴	木				淡	野	難	波	小	林	整備									
7 A		吉	田	村	田			吉	田	郷	長	谷	川	貞			吉	田	郷	渡	辺			川	副	長	谷	川	貞			中	井	(渡	辺)				
7 B	谷	口	北	村	植	田		植	田	橋	本	大	野	大	木	橋	本	那	須	桜	井	池	沢		窪	田	北	村	川	副	橋	井	那	須	窪	田			
8 A		石	黒	森	田			森	田	後	藤						伊	藤																		木	原		
マシン	単	バ	ン	チ			マ	シ	ン	ス	タ	デ				単	バ	ン	チ				保	守	点	検	単	バ	ン	チ						単	バ	ン	チ

The in-house beam lines

	3/28	4/4	4/11	4/18	4/25	5/2	5/9	5/16	5/23	5/30	6/6	6/13	6/20	6/27	7/4	7/11	7/18	7/25	8/1	8/8	8/15	8/22	8/29	9/5	9/12	9/19	9/26											
1 A	小	杉	(高	田)				小	杉	(高	田)			直	江	細	川	小	杉	(高	田)			小	杉	(高	田)											
2 A			正	島	田	林		正	島					正	島		神	田	田	林				笠	井	松	下											
2B2	見	附	(吉	田)				見	附	(吉	田)	旗	野	見	附	(吉	田)								見	附	(吉	田)	旗	野	見	附	(吉	田)				
3 B	見	附	(服	部)					見	附	(服	部)													見	附	(服	部)										
4 A		西	尾					西	尾	イル	ファン	西	尾		今	泉	西	尾	宇	理	須	西	尾		宇	理	須	今	泉									
4 B		大	橋					正	島	宇	理	須	大	橋	宇	理	須	大	橋					宇	理	須	大	橋	宇	理	須							
6A2	鎌	田	(藤	井)				木	村	藤	井	岩	佐	森			山	田	浅	野					鎌	田	福	井										
6 B	葉	師	(鶴	川)					葉	師	(鶴	川)														葉	師	(鶴	川)									
8B2		関		長	谷	川		高	橋	上	野	関			口	野		宮	崎	長	谷	川			関		上	野	高	橋	長	谷	川					
マシン	単	バ	ン	チ			マ	シ	ン	ス	タ	デ			単	バ	ン	チ				保	守	点	検	単	バ	ン	チ						単	バ	ン	チ

	10/3	10	17	24	31	11/7	14	21	28	12/5	12	19	26	1/2	9	16	23	30	2/6	13	20	27	3/6	13	20	27		
1 B	太田	中川和	平木	吉成	伊藤	藤稔	中川英	林哲	辻林	大野	神野	黒沢	中川和															
2B1	松島	松本	関	大内					田中																			
3A1	西尾	吉田	中川英	鎌田					山	林浩																		
3A2		川崎	窪田	増岡	小谷野				川崎	増岡	小谷野																	
5 B	林浩	池沢	木村	岡野	山下	岡野	山下		木村	荒川	見附	山下																
6A1	フェルナ	木村	難波		小林				木村	小林	浅香																	
7 A	植田Ge	吉田Ge	長谷川Ge	セツティング	長谷川	長谷川B	松川B	吉田B郷	渡辺B	吉田B郷	村田コルツ	渡辺B	吉田郷															
7 B	桜井	西井	藤田	福井	宮水	服部	谷口	大木	細野	木村	西井	武部	那須															
8 A	木原	伊藤	藤寛	森田					後藤	石黒																		
マシン	ウィ	グラ	(4T)	マシン	スタ	ディ	単	バ	ン	チ	単	バ	ン	チ	シャ	ド	ウ	ン	単	バ	ン	チ						

	10/3	10	7	24	31	11/7	14	21	28	12/5	12	19	26	1/2	9	16	23	30	2/6	13	20	27	3/6	13	20	27		
1 A	小杉	小杉	小杉	小杉																								
2 A	田林	河野	河野	田林																								
2B2	吉田	吉田	吉田	鶴飼	吉田																							
3 B	服部彦坂	服部彦坂	服部彦坂	服部彦坂																								
4 A	イルファン	今泉	今泉	津坂	緒方	津坂	緒方	今泉	イルファン	緒方	宇理須																	
4 B	吉越	大橋	永園	吉越	大橋	永園	吉越	宇理須	大橋	正	島	永園	吉越															
6A2	広瀬	Chn yong	広瀬	木村	鎌田				1/5	Seo	CAI																	
6 B	薬師鶴川	薬師鶴川	薬師鶴川	薬師鶴川																								
8B2	長谷川	高橋	上野	川副	上野	宮崎	石井	日野	石井	宮崎	高橋	宮崎	長谷川	石井	宮崎													
マシン	ウィ	グラ	(4T)	マシン	スタ	ディ	単	バ	ン	チ	単	バ	ン	チ	シャ	ド	ウ	ン	単	バ	ン	チ						

BL1A Soft X-Ray Beamline for Photoemission-Photoabsorption Spectroscopy

BL1A is a soft x-ray beamline for photoemission-photoabsorption spectroscopy. The beamline is equipped with a focusing premirror and a double crystal monochromator[1]. The monochromator serves soft x-rays in the energy range from 585 to 4000 eV by using several kind of crystal. The throughput spectra of the monochromator crystals are shown in Fig.1. In the energy range from 830 to 1800 eV, a pair of beryl crystals is used with the typical energy resolution ($E/\Delta E$) of 1500. Beryl is known to be damaged easily by x-ray irradiation. We have found that the beam intensity from a new beryl crystal is reduced to about 60% of the initial value after 8 hours irradiation due to the damage. The energy width is broadened by about 20 % at the same condition. In order to obtain spectra efficiently, the irradiation area on the first monochromator crystal is changed every day by moving the crystal position. We are planning to coat the crystal surface thinly with Al and/or insert the Al filter to suppress the x-ray irradiation above Al K-edge (1560 eV).

Recently, a new ultra-high-vacuum (UHV) apparatus for photoemission-photoabsorption spectroscopy has been constructed at the beamline. The detailed design and performance are reported in this issue. The apparatus is equipped with a high-performance electron analyzer (SES-200) manufactured by SCIENTA. Using the apparatus, it has become possible to measure the resonant photoemission spectra. The soft x-ray absorption spectra can be measured in the electron and fluorescent x-ray yield modes. The electronic structure of transition metal compounds and catalytic samples has been studied by the methods.

Reference

[1] A.Hiraya et al., Rev. Sci. Instrum., **63** (1992) 1264.

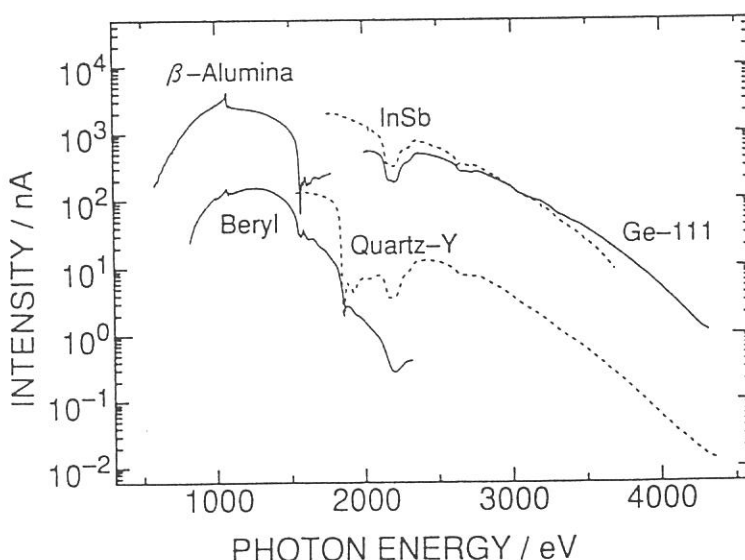


Fig.1. Throughput spectra of double crystal monochromator at BL1A measured by using an electron multiplier with Au first dynode. Intensity is normalized by 100 mA ring current.

BL1B and BL7B: Seya-Namioka Monochromator

BL1B and 7B are beamlines for standard optical measurements in the visible to vacuum ultraviolet region. There is no particular difference among these two beamlines. The multipurpose UHV chamber is installed at the focal point of the Seya-Namioka monochromator. It is easy to handle and obtain optical spectra (absorption, reflection, emission, and excitation, etc.). Samples usually measured are solids, but it is possible to measure the liquid, gases, and biological samples with a LiF window.

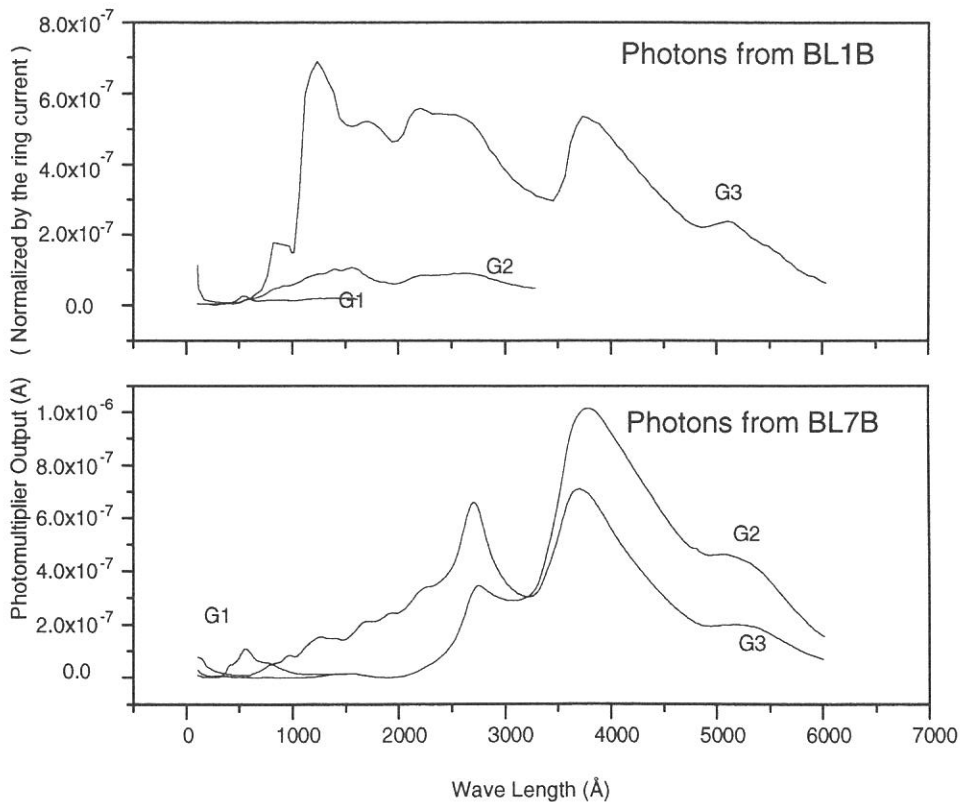
These can also be used for the time-resolved measurements, for instance, an investigation about lifetime of luminescence, when the UVSOR storage ring is operated in the single-bunch mode.

Summary of the specification are listed in Table 1. It is noted that the No.2 grating (G2) in BL7B have been 600 /mm in spite of 1200/mm since January 1994.

Gratings	:G1;2400, G2;1200, G3;600 /mm (Changeable in the vacuum)
Spectral range:	300 ~ 6500 Å
Resolution	: ~1 Å
Period	: 178 ns (Single bunch operation)
Bunch length	: 0.4 ns (Single bunch operation)

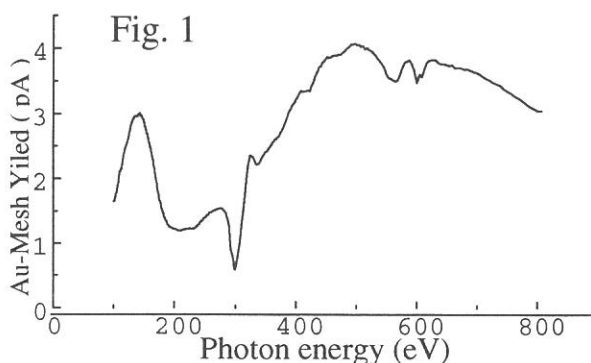
Table 1

The overall spectra from the monochromators are shown below.



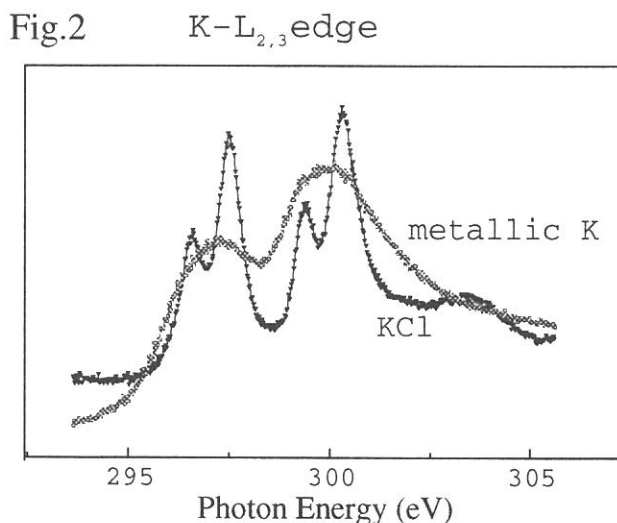
BL2B1: Soft-X ray beamline for solids and solid surfaces

BL2B1 is a beamline in order to study solids and solid surfaces by the use of photoabsorption and photoelectron spectroscopy. A 2-meter grazing incidence monochromator ('Grasshopper' type, Mark XV; Baker Manufacturing Co.) is installed. Three kinds of grating are prepared (600, 1200, 2400 l/mm), and 2400 l/m has been installed since April 1994. The energy range for this grating is from 95 eV to 1000 eV. The resolving power is better than 600 at C-K edge (about 290 eV). Figure 1 shows the photoelectron yield from the Au mesh (10%-transmission) located near the position of a sample. The dip around 300 eV is due to carbon contamination of optical elements.



The analyzing chamber is installed at the focusing point of the monochromized light. The pressure is less than 1×10^{-10} Torr. A double-pass CMA with a coaxial electron gun, a LEED optics, an ion-gun for sputtering, and a sample holder which can be cooled with liquid nitrogen and heated, etc. are equipped for 'in-situ' measurements in the analyzing chamber. The photoelectron spectroscopy including CIS (Constant initial state spectroscopy), CFS (Constant final state spectroscopy) can be measured using CMA which is controlled by a personal computer. Samples can be transferred to the analyzing chamber from the air, through the preparation chamber in which sample treatment (e.g. cleaving, filing, and deposition) can be made.

Figure 2 shows an example of spectra measured at BL2B1. These are K- $L_{2,3}$ edge absorption spectra of KCl and metallic K films deposited on the sample holder made of Mo. Spectra are measured via a partial photoelectron yield by the use of the CMA. The spin-orbit splitting (L_2 and L_3) of the initial state of metallic K and KCl are clearly observed, and the splitting due to the final state of KCl are also clearly observed.



BL3A1 Irradiation Port with Undulator Radiation

A planar-type undulator installed in a long straight section of the UVSOR storage ring provides an intense quasi-monochromatic radiation to the beam line 3A1 or 3A2. The undulator consists of 24 sets of magnets, a period length of which is 80 mm. The photon-energy range from 8 to 50 eV can be covered by the fundamentals, although the large amounts of higher harmonics are mixed into the spectral distribution with increasing the K-value. The beam line 3A1 has no monochromator between the undulator and a sample chamber. The undulator radiation is introduced into samples through a pinhole (1 or 2 mm in diameter before the premirror chamber), a toroidal focussing mirror, another pinhole (1 mm in diameter near the sample chamber), and filters (Al, Sn, and In). A three-stage differential pumping system is available to be installed for the experiments such as etching and CVD. A typical spectrum distribution measured at BL 3A2 is shown in Fig. 2, where the undulator gap is 60 mm and the value of photon flux is 10^{14} – 10^{15} phs/s/mm².

A variety of experiments by using the intense undulator radiation such as photo-desorption, SR-CVD, photo-etching, and light-amplification induced by core-level excitation have been carried out in recent years. The irradiation effects of vacuum ultraviolet radiation to useful semiconductors and amorphous materials have also been measured at this station. The luminescence from high- T_c superconductors, the fluorescence yield of which is very low, can be obtained with the undulator radiation. The decay time measurements of luminescence have also been carried out on many samples under single-bunch operation.

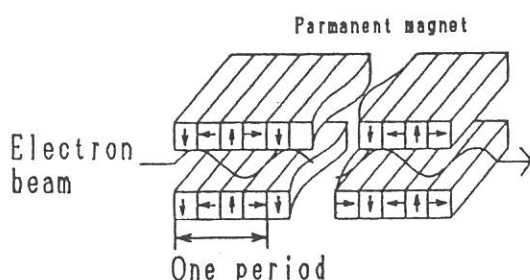


Fig. 1 Schematic drawing of undulator

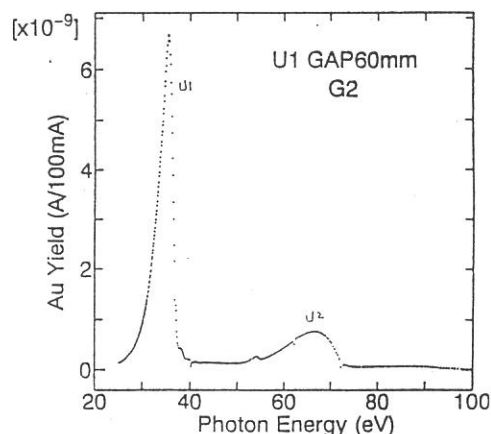
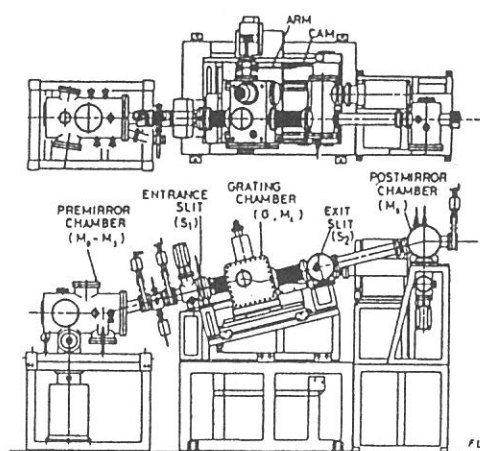


Fig. 2 Typical spectrum of undulator

BL3A2 Gas-Phase Dissociative Photoionization Apparatus

This machine has been constructed to study the formation of multiply-charged ions and their dissociation processes. The monochromator is constant-deviation grazing-incidence type with 2.2 m focal length and covers wide wavelength range from the region around the first ionization potentials of almost all molecules (~ 100 nm) to the region where multiply-charged ions are effectively produced (~ 10 nm). High intensity photon beam is available by introducing the radiation emitted from the undulator to the monochromator. The apparatus contains an angle-resolved time-of-flight mass spectrometer (TOFMS) equipped with automatic data acquisition system for photoion-photoion coincidence measurements. For full understanding of dissociative multiple photoionization, we detect the coincidence signals of two fragment ions produced from a parent ion, evaluate the kinetic energy release in "Coulomb explosion", and measure the angular distributions for the fragment ions. The sensitivity with respect to high-speed ions (several tens of electron volts) is much improved in comparison with commercial TOFMS.



Application

This apparatus allows us to measure the partial cross sections for the multiple ionization of polyatomic molecules and the branching ratios for various fragment channels. On the basis of the kinetic energy distribution of the fragment ions, we have discussed the detail of dissociative potential energy surfaces relating to double photoionization.

Specifications

Monochromator	: 2.2 m constant-deviation grazing-incidence
Spectral range	: 10 - 100 nm
Resolution	: 0.009 nm at 13 nm
Mass spectrometer	: double-field time-of-flight type
Mass Resolution	: 300
Length of the drift tube	: 0.2 - 1 m
Rotatable Angle	: 0 - 90° with respect to the photon beam

BL5B Calibration Apparatus of optical elements

BL5B has been constructed to calibrate optical elements. The beam line consists of a plane grating monochromator (PGM) and a calibration chamber (Fig. 1). The calibration chamber is equipped with a goniometer. The beam line is able to accommodate an additional experimental apparatus downstream after the chamber. The spectral range of the PGM is 2 - 240 nm (Fig. 2) and the resolution is 500 ± 200 in this range. The volume of the calibration chamber is $\sim 0.5 \text{ m}^3$, and the pumping system evacuates the chamber to a operating pressure (less than 3×10^{-5} torr) from the atmosphere during ~ 1 hour. The goniometer, which was installed for the characterization of optical components, has six degrees of freedom: coaxial rotations of sample and detector, X-Y translation of a sample, and interchange of samples and filters. They are driven by vacuum pulse motors. Since the polarization of SR is essential for such measurement, axis of the rotation can be made in either horizontal or vertical direction.

By using the chamber, and also by using the ultrahigh vacuum chamber on the beam line downstream, various researches such as 1) calibrations optical components, 2) measurements of reflectivity spectra of materials in the photon energy range 10 - 200 eV, 3) measurements on photo-stimulated desorption from solid rare gases condensed on a cryogenic surface, and 4) time resolved detection of photoemission after the irradiation of VUV light using an electron streak camera, have been carried out.

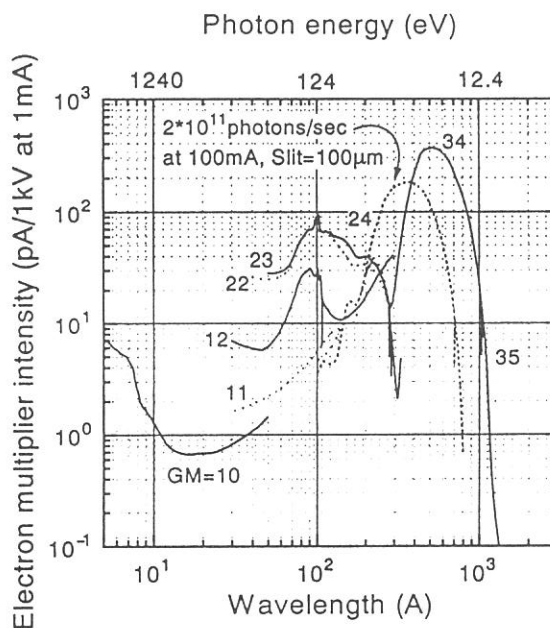


Fig. 2. Throughput spectra of BL5B detected by an electron multiplier.

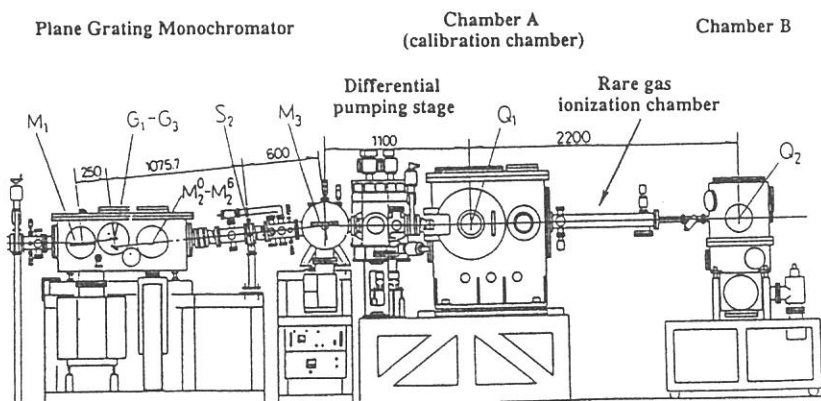


Fig.1. Schematic figure of BL5B spectrometer system.

BL6A1 Fourier Transform Far-Infrared Spectroscopy

Although the synchrotron radiation (SR) is a strong light source in the vacuum ultraviolet region, the spectral distribution extends down to the far-infrared region. Since the bunch of electrons is very small, the brightness is higher than a conventional light source. This property of SR is powerful especially for small samples. As a matter of fact the intensity of UVSOR is 10 times larger than the high-pressure mercury lamp when the sample size is smaller than 3 mm. The far-infrared spectrometer of BL6A1 was constructed to measure the absorption or reflection of such a small size.

Specification

method	: transmission or reflection
spectral range	: $33 \mu\text{m} \sim 2 \text{mm}$ ($300 \sim 5 \text{cm}^{-1}$, $37 \sim 0.6 \text{meV}$)
resolution	: 0.1cm^{-1}
temperature	: $9 \sim 350 \text{K}$
pressure	: $0 \sim 20 \text{GPa}$ (using a diamond anvil cell)

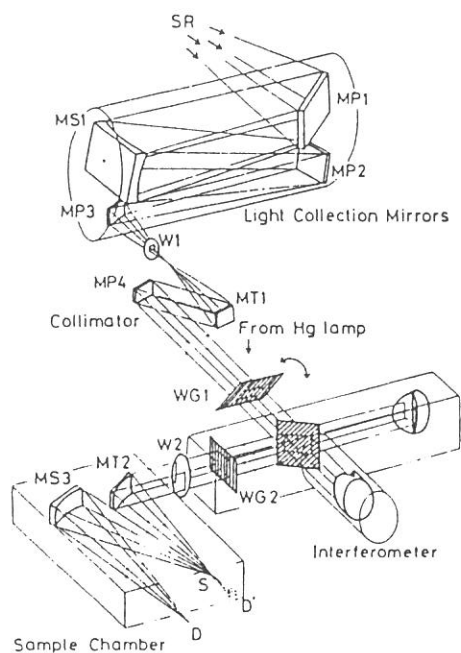
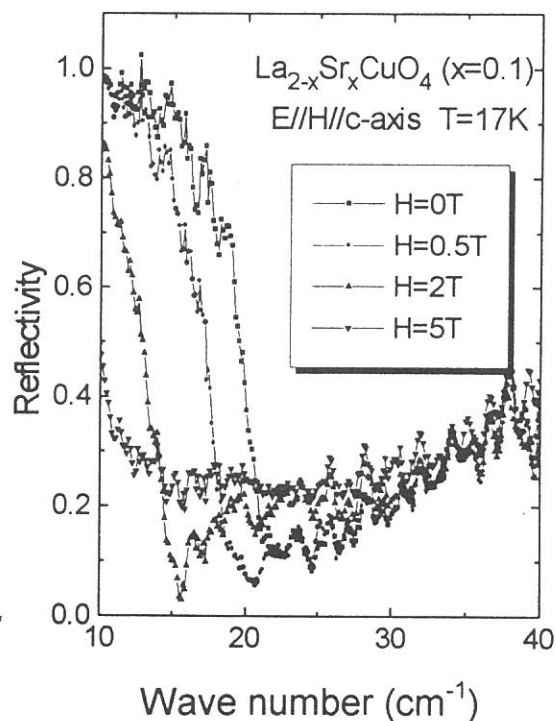


Fig. 1. Schematic drawing of spectroscopic system.

It becomes possible by using UVSOR as a light source to do the spectroscopic study in the far-infrared region on small samples. Recently many attractive materials such as copper oxide superconductors, strongly correlated electron systems, superionic conductors and so on are investigated. Since SR is a highly collimated, it is powerful for the spectroscopic experiment at low-temperature, under high-pressure and under high-magnetic field where the solid angle is restricted to a small range.

Fig. 2. Reflectivity spectra of $\text{La}_{2-x}\text{Sr}_x\text{CuO}_4$ ($x \sim 0.1$) under magnetic field.



BL6A2 Photoelectron Spectrometer for Solids and Surfaces

A Plane Grating Monochromator (PGM) consists of pre-mirrors, a plane grating, focussing mirror, and a post-mirror, with an exit slit. It covers the wide spectral range from 2 to 130 eV with exchanging two gratings and 5 focussing mirrors. A typical photon flux is about 10^{11} phs/s/100 mA at 90 eV with a resolving power of 700. Angle-integrated and angle-resolved photoelectron spectrometers are available at BL6A2. The overall resolution of the angle-integrated cylindrical retarding-field analyser is fixed to be 0.3 eV, while the angle-resolved hemispherical analyser has a resolving power of 100 with an angular resolution of 1.1° . The optical system including an ICCD system can be installed to detect the fluorescence from the samples through a quartz lenze and a sapphire window. The standard instruments for surface analysis such as Auger, LEED, Ion gun, and Gas doser are installed in the analysing chamber, the base pressure of which is 1.2×10^{-10} Torr. The samples are transferred from an air-lock chamber to the analysing chamber through a preparation chamber.

The photoelectron spectroscopy is a powerful method to know the occupied states of many materials. The III-V semiconductors, layered materials, dielectric films, and metallic substances have been investigated at BL6A2, as well as the clean and adsorbed surfaces of semiconductors (Si, Ge, and GaAs). The angle-resolved photoelectron spectra have also been observed to know the band dispersion. Moreover, the time response of the photo-desorption of excited-state alkali atoms from alkali halides has been observed by using the TAC system under a single-bunch operation.

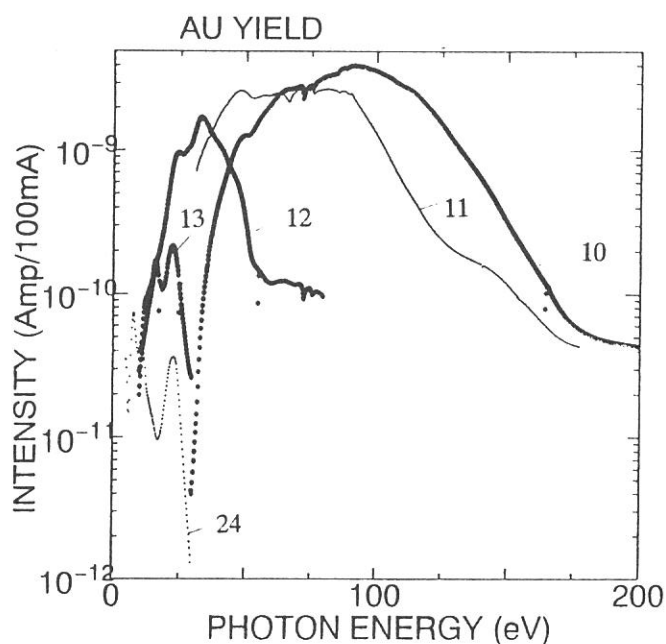


Fig. 1 Typical spectral distribution

BL6B Fourier-Transformed Far-Infrared Spectrometer

BL6B has been designed to measure reflectance on small samples with high precision over FIR-IR regions. The optical system of BL6B consists of the following three parts: (1) beamline optics in ultrahigh vacuum (1×10^{-9} Torr), equipped with interchangeable four kinds of exit-window without breaking the vacuum, (2) adjusting optics between the beamline and a spectrometer, (3) a Bruker IFS-113v spectrometer, which offers automatic change of six beam-splitters under vacuum (~ 5 Torr). A reflectance unit is placed into a sample compartment of the spectrometer, also in the vacuum atmosphere. Temperature dependence can be traced with a LHe flow type cryostat from room temperature down to 4 K. An infrared microscope is applied, if necessary, to obtain accurate reflectivity on samples smaller than millimeter size. Table 1 summarizes the optical elements used in each wave-number range.

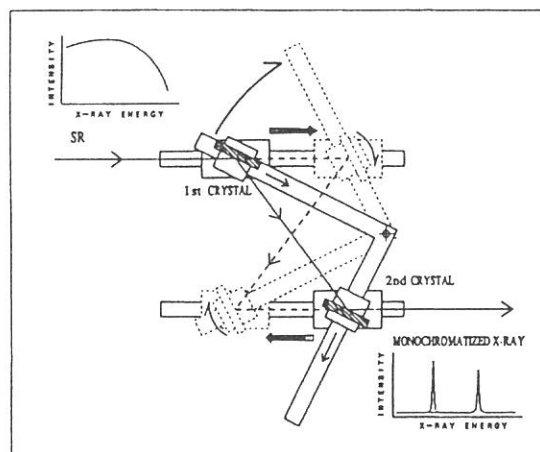
range (cm ⁻¹)	source	beam-splitter	optical filter (cut-on)
2000-10000	Tungsten	Si on CaF ₂	none
500-5000	Globar	Ge on KBr	none
150-650	Hg lamp	Mylar 3.5 μ	700 cm ⁻¹
70-220	Hg lamp	Mylar 12 μ	700 cm ⁻¹
20-80	Hg lamp	Mylar 23 μ	100 cm ⁻¹
6-30	SR	Mylar 125 μ	35 cm ⁻¹

Table 1. Optical elements.

BL6B is specially suitable for the study of optical properties of organic conductors because available size of the crystals is usually very small. We are now investigating the electronic structure of organic conductors that have a single-particle gap appeared in far-infrared region, caused by SDW, CDW, or superconducting transition. The superconducting character is also discussed through the change of reflectivity versus the temperature around the T_c .

BL7A Soft X-ray Spectrometer for Solids

In the soft X-ray region from 0.5 to 5 keV, there exist 1s core absorptions of light atoms from oxygen to calcium which take important role in the various fields of chemistry (organic, inorganic, catalytic, and biological) and other core absorptions of heavier atoms. By measuring the X-ray absorption, and the emission of electrons, X-ray fluorescence, and UV-visible light after the excitation of 1s or other core electrons of these atoms, structural and dynamical information of molecules, solids and catalysts, can be obtained. The soft X-ray beam line BL7A equipped with a double crystal monochromator



(DXM) was constructed for the spectroscopic research in the soft X-ray region. The DXM at BL7A was designed to realize the constant offset and constant direction during the scanning of the X-ray energy. As shown in the figure two crystals move along each arm of an L-shaped base. The first crystal's surface is mounted parallel to one arm while the second crystal's surface is mounted perpendicular to another arm so that two surfaces should be parallel. The reflection points of the first crystal and second crystal move along the incident SR beam axis and along the monochromatized X-ray beam axis, respectively. The rotation center of the L-shaped base (cross point of the extension line of the first crystal's surface and the normal line of the second crystal's surface at the reflection point) is fixed on the bisecting level of the incident SR beam and the monochromatized X-ray beam. By rotating the L-shaped base, incident angle to the crystal's that is, X-ray energy can be changed with keeping the offset and direction of the X-ray constant.

Specification

Scanable energy range :

CRYSTAL (MULTILAYER)	$2d/\text{\AA}$	energy range				
		1	2	3	4	5
KAP	26.64	0.49 — 1.36				
(W/B ₄ C)	25.7	0.51 — 1.41				
Mica	19.8	0.66 — 1.83				
Beryl	15.965	0.82 — 2.27				
Quartz-Y(1010)	8.512	1.53 — 4.26				
InSb-111	7.481	1.74 — 4.85				
Ge-111	6.532	2.00 — 5.55				

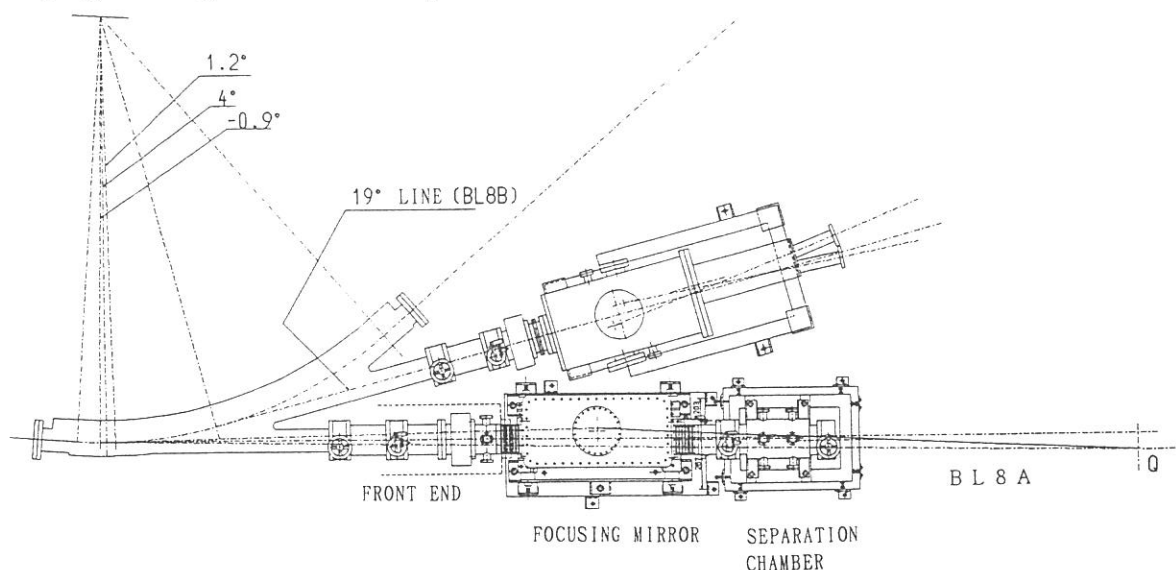
Resolution : 0.46 eV (Crystal = Beryl, E = 860 eV)

Measurements : Transmission, total photoelectron yield

Sample : Gas, solid (room temp. - 20 K)

BL8A Free Port

This beamline was constructed as a free port to which user can connect their own instruments. The beamline consists of a front end, a focusing premirror chamber and a separation chamber. Both focused and unfocused beam can be used. A general purpose reaction chamber and a two (or three) stage differential pumping system are available for the experiments that use gas samples without window. With using three stage differential pumping system, gas pressure at the reaction chamber upto 0.5 Torr can be used while keeping ultra high vacuum at the premirror chamber.



specification

spectral range: whole range of synchrotron radiation from UVSOR

Acceptance angle

Unfocused beam: 25 mrad (horizontal) × 8 mrad (vertical)
0.6 mrad (horizontal) × 0.6 mrad (vertical)
(with 3mm ϕ aperture before sample)

Focused beam: 7.7 mrad (horizontal) × 8 mrad (vertical)
[Beam spot size at focus : 3 mm (horizontal) × 2 mm (vertical)
[Source - mirror distance: 2500 mm
[Mirror - focus distance: 2807 mm

Application

SR assisted Chemical Vapor Deposition

SR assisted Etching

Radiation damage

Soft X-ray microscopy

Accumulated photon echo

BL8B1 Photoabsorption and Photoionization Spectrometer

BL8B1 is the beamline for high resolution photoabsorption and photoionization experiments mainly in the photon energy range from 200 to 800 eV where the 1s core absorption of C, N, O atoms exist. For this purpose a constant-deviation constant-length spherical grating monochromator (CDCL-SGM) with three interchangeable gratings was constructed at this beamline. The CDCL-SGM has simple scanning mechanism with fixed position of both the entrance and exit slits, as well as fixed direction of incident and exit photon beams. The monochromator covers 30 ~ 800 eV by using three gratings (G1: R=15m; 1080 l/mm, G2: R=15m; 540 l/mm, G3: R=7.5m; 360 l/mm) with photon flux of $10^8 - 10^9$ photons/sec for 10 μm slits and at 100 mA ring current (Fig. 1). Absolute photon flux was evaluated from drain current of gold foil with assuming constant quantum efficiency of 0.073. In the photon energy range from 180 to 800 eV, observed resolutions ($E/\Delta E \approx 4000$ at 400 eV, $E/\Delta E \approx 3000$ at 245 eV) with 10 μm slits agree well the calculated values (Fig. 2).

Several types of gas phase experiments are possible with using an experimental chamber equipped with a photoelectron detector (total- or threshold-), a time-of-flight ion detector, and a built-in VUV monochromator for emission detection (under preparation). An example of fragment-ion mass spectrum of core-excited molecule is reported in this issue (BL8B1). It is also possible to measure absorption, electron yield, and emission spectrum of solid samples.

1. Absorption spectrum with transmission mode
2. Total electron yield and/or total ion yield spectrum
3. Emission spectrum (Visible to VUV) and emission excitation spectrum
4. Time-of-flight mass: photoelectron-photoion coincidence (PEPICO)
5. Photoion-photoion coincidence (PIPICO)

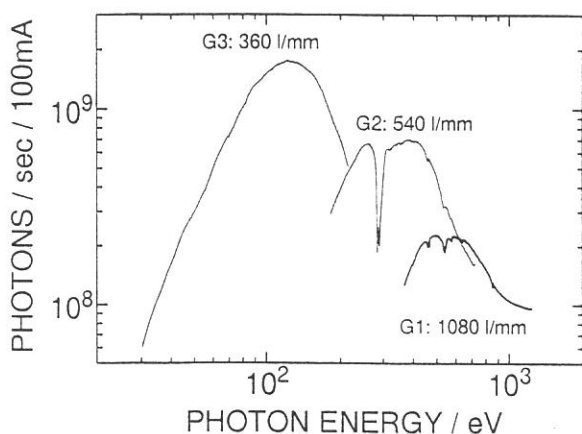


Fig. 1. Throughput spectra (absolute photon flux) of CDCL-SGM for three gratings with 10 μm slits and at 100mA ring current.

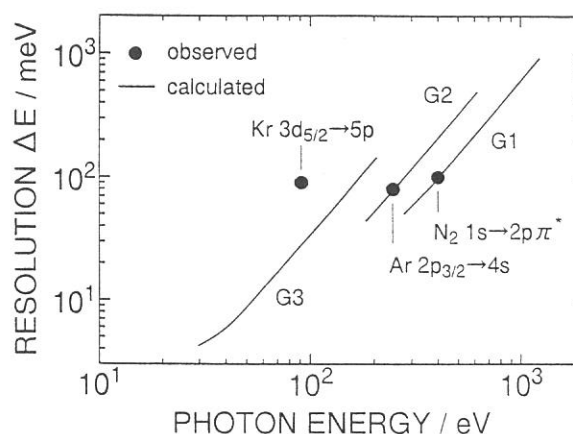


Fig. 2. Energy resolution of CDCL-SGM for three gratings with 10 μm slits. Solid lines: calculated values, filled circle: observed values.

BL8B2 Angle-resolved UPS system

An angle-resolved ultraviolet photoemission spectroscopy (ARUPS) system at BL8B2 is shown in Fig.1. The ARUPS system consists of a preparation chamber with a glove box, a measurement chamber with an accurate manipulator for temperature dependence, a new cleaning chamber and a new sample preparation chamber. The new cleaning chamber are also equipped with LEED/AUGER, Ar^+ gun and an infrared heating units. Each chamber is evacuated by a combination of a sputter ion pump, a turbo-molecular pump and a Ti getter pump with a final pressure of 10^{-8} Pa range. Synchrotron radiation from UVSOR is monochromatized by plane-grating-monochromator (PGM) which supplies radiation in the energy range of 2-150eV. This range covers the whole valence excitation of various solids. A hemispherical electron-energy analyzer of 25mm mean radius can be rotated around vertical and horizontal axes. The sample mounted on a manipulator can be also rotated around two axes. The spot size of the zeroth-order visible light at the sample is focused less than $1 \times 1 \text{mm}^2$. The total resolution is less than 0.3eV, as determined by measuring the Fermi edge of gold. The sample are prepared on a small disk of 10mm in diameter by methods such as vacuum evaporation and cleavage in the preparation chamber or the glove box under Ar atmosphere.

The ARUPS system at BL8B2 are designed for measuring various organic solids such as molecular crystals and conducting polymers. Then, we measured ARUPS spectra of copper phthalocyanine (CuPc) thin films deposited on MoS_2 surface. The freshness of the cleaved MoS_2 surface was confirmed by ARUPS and low energy electron diffraction (LEED) measurements before the film deposition. By comparing the results of LEED and ARUPS measurements, we determined the orientation of the CuPc molecules on the MoS_2 surface by the quantitative analysis of the observed angular distribution using the IAC (Independent Atomic Center) approximation method.

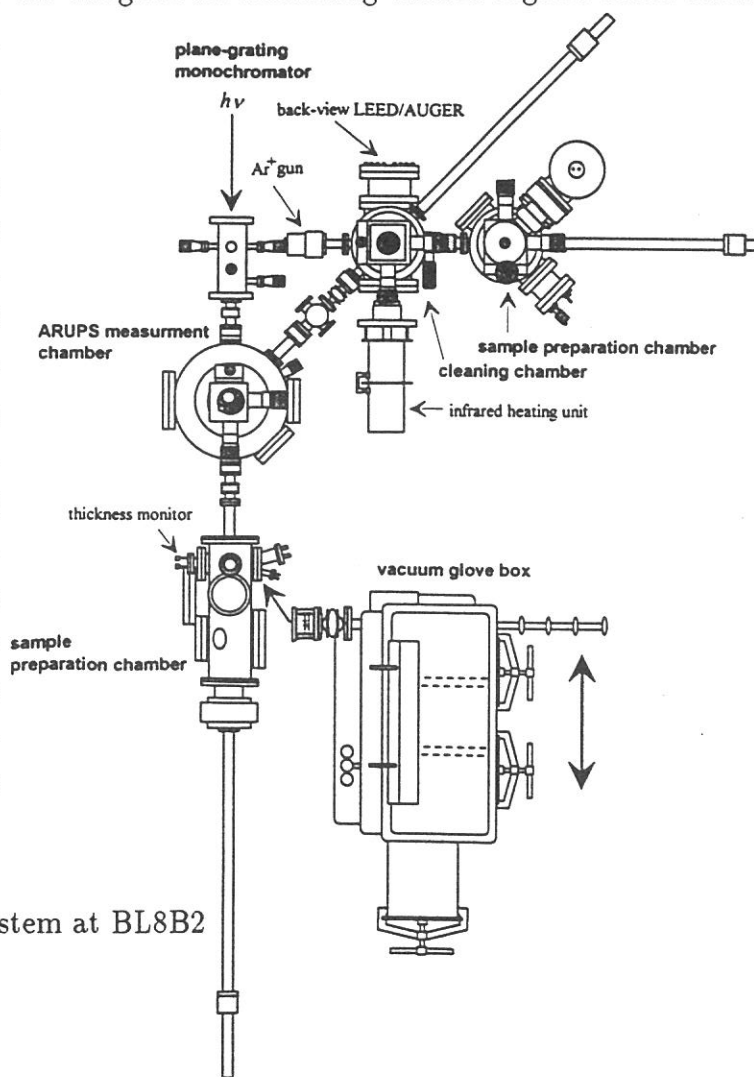


Fig.1 The top view of ARUPS system at BL8B2



Appendix

ORGANIZATION

Staff			[e-mail address]
<i>Director</i>			
Kyuya	YAKUSHI	Professor (- March 1994)	
Nobuhiro	KOSUGI	Professor (April 1994 -)	kosugi@ims.ac.jp
<i>Scientific Staff</i>			
<i>Light Source</i>			
Goro	ISOYAMA	Associate Professor (- March 1994) Adjunct Professor from Osaka Univ. (April 1994 - September 1994)	
Hiroyuki	HAMA	Associate Professor (January 1995 -) Research Associate (- January 1995)	hama@kekvox.kek.jp
<i>Beam Line</i>			
Masao	KAMADA	Associate Professor	kamada@ims.ac.jp
Toyohiko	KINOSHITA	Associate Professor (October 1994 -)	toyohiko@ims.ac.jp
Atsunari	HIRAYA	Research Associate	hiraya@ims.ac.jp
Shin-ichiro	TANAKA	Research Associate	stanaka@ims.ac.jp
Shin-ichi	KIMURA	Research Associate	kimura@ims.ac.jp
<i>Technical Staff</i>			
Kusuo	SAKAI	Section Chief Engineer	ksakai@ims.ac.jp
Osamu	MATSUDO	Section Chief Engineer	matsudo@ims.ac.jp
Toshio	KINOSHITA	Unit Chief Engineer	kinosita@ims.ac.jp
Masami	HASUMOTO	Engineer	hasumoto@ims.ac.jp
Jun-ichiro	YAMAZAKI	Engineer	yamazaki@ims.ac.jp
Eiken	NAKAMURA	Engineer	eiken@ims.ac.jp
<i>Secretary</i>			
Hisayo	HAGIWARA		hagiwara@ims.ac.jp
<i>Guest Scientist</i>			
Kazumichi	NAKAGAWA	Adjunct Associate Professor from Kobe Univ.	nakagawa@kobe-u.ac.jp
Yong Q.	CAI	JSPS Foreign Research Fellow (January 1995 -)	ycai@ims.ac.jp
Sayumi	HIROSE	Toyota Research Fellow (April 1994 -)	hirose@ims.ac.jp
<i>Graduate Student</i>			
Naoshi	TAKAHASHI	(April 1994 -)	naoshi@ims.ac.jp
Kazuhiko	KIMURA	(April 1994 -)	kmrkzhk@ims.ac.jp

Representative of Beam Lines (January 1995)

BL1A	Nobuhiro	KOSUGI	Dept. Vacuum UV Photoscience
BL2A	Nobuhiro	KOSUGI	Dept. Vacuum UV Photoscience
BL2B2	Koichiro	MITSUKE	Dept. Vacuum UV Photoscience
BL3B	Koichiro	MITSUKE	Dept. Vacuum UV Photoscience
BL4A	Tsuneo	URISU	Dept. Vacuum UV Photoscience
BL4B	Tsuneo	URISU	Dept. Vacuum UV Photoscience
BL6A2	Masao	KAMADA	UVSOR
BL6B	Kyuya	YAKUSHI	Dept. Molecular Assemblies
BL8B2	Nobuhiro	KOSUGI	Dept. Vacuum UV Photoscience
Others	Masao	KAMADA	UVSOR
	Toyohiko	KINOSHITA	UVSOR

Steering Committee (April 1994 - March 1996)

Nobuhiro	KOSUGI	IMS Chairman
Noriaki	ITO	Nagoya Univ. (- March 1995)
Akito	KAKIZAKI	Univ. of Tokyo
Toshio	KASUGA	KEK
Tadashi	MATSUSHITA	KEK
Toshiaki	OHTA	Univ. of Tokyo
Inosuke	KOYANO	Himeji Inst. of Technology
Toshio	IBUKI	Kyoto Univ. of Education
Kazumichi	NAKAGAWA	Kobe Univ., IMS
Norio	MORITA	IMS
Yoshiyasu	MATSUMOTO	IMS
Koichiro	MITSUKE	IMS
Masao	KAMADA	IMS
Toyohiko	KINOSHITA	IMS
Hiroyuki	HAMA	IMS

JOINT STUDIES (fiscal year 1994)

Special Project	: 2
Cooperative Research	: 28
Cooperative Research (invited)	: 9
Use of Facility	: 126
Use of Facility (Private Company)	: 1
Workshop on VUV beam lines	: 1
Workshop on Beam Dynamics and Free Electron Laser	: 1
User's time	: 37 weeks

LIST OF REPRESENTATIVE OF COOPERATIVE RESEARCH (fiscal year 1994)

Chiba Univ.	Hino, S.	Ueno, N.		
Ehime Univ.	Nagaoka, S.			
Fukui Univ.	Fukui, K.	Nakagawa, H.		
Gakushuuin Univ.	Arakawa, I.			
Himeji Inst. of Technology	Koyano, I.			
Hiroshima Univ.	Hosokawa, S.	Tabayashi, K.		
Hokkaido Univ.	Kawasaki, M.	Matsushima, T.	Sato, S.	
Iwaki Meisei Univ.	Kanda, K.			
Kagawa Univ.	Itoh, H.	Kawase, M.		
Kanazawa Univ.	Naoé, S.			
Kansai Medical Univ.	Kihara, H.			
Kobe Univ.	Nakagawa, K.	Nanba, T.	Ohta, H.	Sakurai, M.
Kyoto Univ.	Asano, M. Yoshida, S.	Hayashi, T.	Kan'no, K.	Tanaka, T.
Kyoto Univ. of Education		Hashimoto, S.	Ibuki, T.	Murata, T.
Kyushu Univ.	Takebe, H.			
Maritime Safety Academy	Fujita, M.			
Mie Univ.	Nasu, H.			
Miyazaki Univ.	Kurosawa, K.			
Nagoya Univ.	Goto, T. Ouchi, Y. Yamashita, K.	Ishii, H. Seki, K.	Mori, M. Shobatake, K.	Morita, S. Taniguchi, M.
Nagoya Inst. of Technology	Yamada, M.			
Naruto Univ. of Education	Matsukawa, T.			
Osaka Univ.	Aritome, H. Kasai, T.	Hiraki, A. Kobayashi, H.	Inoue, K. Kobayashi, M.	Isoyama, G. Oyama, H.

Osaka City Univ. Fujii, Y. Ishiguro, E. Masuoka, T.
Osaka Dental Univ. Tsujibayashi, T.
Osaka Electro-Commun. Univ. Ohno, N.
Univ. of Osaka Prefecture Ichikawa, K. Soda, K.
Osaka National Research Inst. Kitamura, N. Nishii, J.
Rikkyo Univ. Kubota, S.
Univ. of Ryukyus Ejiri, A.
Saga Univ. Ogawa, H.
Shinshu Univ. Itoh, M.
Tohoku Univ. Hattori, T. Ikezawa, M. Suzuki, T. Takahashi, T.
Watanabe, M.
Tohoku Gakuin Univ. Awano, T.
Univ. of Tokyo Iwasa, Y. Okano, T.
Tokyo Inst. of Technology Hatano, Y. Hikida, T. Hosono, H.
Tokyo Gakugei Univ. Hasegawa, S.
Tokyo Metropolitan Univ. Nishida, H.
Tottori Univ. Ouchi, I.
Toyohashi Univ. of Technology Yoshida, A.
Utsunomiya Univ. Nakai, S.
Wakayama Univ. Miyanaga, T.
Waseda Univ. Ohki, M.
Yamagata Univ. Yoshinari, T.
IMS Asaka, S. Hasegawa, S. Hayashi, K. Hiraya, A.
Kamada, M. Kawazoe, H. Kimura, S. Kosugi, N.
Matsumoto, Y. Mitsuke, K. Miyazaki, H. Nishio, M.
Rull, F. Tanaka, S. Ueda, N. Urisu, T.

UVSOR Workshop
on
Present Status and Future Plans
of
VUV Beam Lines
for Solid-State Research

November 4, 1994 (at Room #101)

13:00- (General Features)

Opening address

N. Kosugi(IMS)

Present status and plans of VUV beam lines

M. Kamada(IMS)

VUV beam lines of INSSOR

S. Shin(Tokyo Univ.)

VUV beam lines of Photon Factory

T. Miyahara(KEK)

VUV beam lines of BESSY

T. Kinoshita(IMS)

15:10-15:30 (Coffee Break)

15:30- (Photoelectron Spectroscopy)

Present and future of BL2B1 and 6A2

S. Tanaka(IMS)

Present and future of BL8B2

K. Seki(Nagoya Univ.)

Status of high-resolution photoelectron spectroscopy

T. Takahashi(Tohoku Univ.)

Status of spin-resolved photoelectron spectroscopy

T. Kinoshita(IMS)

Constant-deviation monochromator at BL8B1

A. Hiraya(IMS)

New project at BL5A

M. Kamada(IMS)

New undulator for circular polarization

S. Kimura(IMS)

17:45- (Free Discussion)

(Remarks by T. Omata(Kanagawa Univ.), S. Hino(Chiba Univ.), Y. Ouchi(Nagoya Univ.),
K. Fukui(Fukui Univ.), T. Matsukawa(Naruto Univ.), and I. Ouchi(Tottori Univ.))

18:30-20:30 (Party)

November 5, 1994 (at Room #101)

9:00- (Seya Region)

Present status of BL1B and BL7B	M. Hasumoto(IMS)
Future plans of BL1B and BL7B	S. Tanaka(IMS)
2-photon spectroscopy	M. Itoh(Shinsyu Univ.)
Expectancy from exciton physics	T. Hayashi(Kyoto Univ.)
Expectancy in the window region	K. Nakagawa(Kobe Univ.)
Proposal for BL7B	H. Nakagawa(Fukui Univ.)

10:55- (Free Discussion)

(Remarks by K. Kan'no(Kyoto Univ.), K. Kurosawa(Miyazaki Univ.), T. Matsumoto(Kyoto Univ.), N. Eimori(Osaka Univ.), T. Nanba(Kobe Univ.), and M. Fujita(Maritime Safety Acad.))

11:55-13:15 (Lunch)

13:15- (BL3A1 and BL5B)

Present and Future of BL3A1	M. Kamada(IMS)
Desire from irradiation experiments	H. Hayashi(IMS)
Expectancy from SR-CVD experiments	A. Yoshida(Toyohashi Univ.)
Present and future of BL5B	S. Kimura(IMS)
Needs for calibration beam line	K. Yamashita(Nagoya Univ.)
Expectancy from desorption studies	K. Mitsuke(IMS)

14:55-15:10 (Coffee Break)

15:10- (Comments and Free Discussion)

Comment from quantum electronics	H. Itoh(Kagawa Univ.)
Comment from user's side	R. Kato(Kyoto Univ.)

Free Discussion

(Remarks by M. Ashida(Kyoto Univ.), K. Mase(IMS), T. Tsujibayashi(Osaka Dental Univ.), M. Mori(Nagoya Univ.), and M. Watanabe(Tohoku Univ.))

16:40- (User's meeting)

LIST OF PUBLICATIONS(1994)

- 1) "Intrinsic Luminescence in Synthetic Mica Crystals"
M. Itoh, N. Ohno and Y. Uzawa
J. Phys. Soc. Jpn. **63** (1994) 825.
- 2) "FEL Experiment on the UVSOR Storage Ring"
H. Hama, J. Yamazaki and G. Isoyama
Nucl. Instrum. & Methods in Phys. Res. A **341** (1994) 12.
- 3) "Time Response of Photon-Stimulated Desorption of Excited-State Potassium Atoms from KCl and KBr"
S. Hirose and M. Kamada
J. Phys. Soc. Jpn. **63** (1994) 1053.
- 4) "Absorption Spectra of Alkali Cyanide in the Vacuum-Ultraviolet Region: Transitions to Dissociative and Predissociative States"
H. Yasumatsu, T. Kondow, K. Suzuki, K. Tabayashi and K. Shobatake
J. Phys. Chem. **98** (1994) 1407.
- 5) " L_3 Near-Edge Structure in Germanium"
S. Naoé
Jpn. J. Appl. Phys. **32** (1993) 794.
- 6) "Infrared and Transport Properties of K_xC_{60} "
A. Ugawa
Synthetic Metals **56** (1993) 2997.
- 7) "Electronic Structure of Metallofullerene LaC_{82} : Electron Transfer from Lanthanum to C_{82} "
S. Hino, H. Takahashi, K. Iwasaki, K. Matsumoto, T. Miyazaki, S. Hasegawa, K. Kikuchi and Y. Achiba
Phys. Rev. Lett. **71** (1993) 4261.
- 8) "Decay Kinetics of the 4.4 eV Photoluminescence Associated with the Two States of Oxygen-Deficient-Type Defect in Amorphous SiO_2 "
H. Nishikawa, E. Watanabe, D. Ito and Y. Ohki
Phys. Rev. Lett. **72** (1994) 2101.
- 9) "Enhanced Photogeneration of E' Centers from Neutral Oxygen Vacancies in the Presence of Hydrogen in High-Purity Silica Glass"
H. Nishikawa, R. Nakamura, Y. Ohki and Y. Hama
Phys. Rev. B **48** (1993) 2968.

- 10) "Intersystem-Crossing, Momentum Relaxation and Self-trapping of Excitons in Alkali Iodides"
T. Tsujibayashi, K. Toyoda, T. Hayashi, M. Watanabe, P. Gu and K. Kan'no
J. Lumi. **58** (1994) 368.
- 11) "Mo-Si Multilayer as Soft X-Ray Mirrors for the Wavelengths around 20 nm Region"
D. Kim, H. W. Lee, J. J. Lee, J. H. Je, M. Sakurai and M. Watanabe
J. Vac. Sci. Technol. A **12** (1994) 148.
- 12) "Observation of Double Excited Rydberg States of N₂O by Positive Ion-Negative Ion Coincidence Spectroscopy"
H. Yoshida and K. Mitsuke
J. Chem. Phys. **100** (1994) 8817.
- 13) "Defect Creation in Hydrogenated Amorphous Silicon Films Induced by Vacuum Ultraviolet Light from Synchrotron and Undulator Radiation"
Y. Saito and A. Yoshida
Philosophical Magazine B **70** (1994) 133.
- 14) "Low-Energy Optical Excitation in Rare-Earth Hexaborides"
S. Kimura, T. Nanba, S. Kunii and T. Kasuya
Phys. Rev. B **50** (1994) 1406.
- 15) "Demonstration of Accumulated Photon Echoes by using Synchrotron Radiation"
H. Itoh, S. Nakanishi, M. Kawase, H. Fukuda, H. Nakatsuka and M. Kamada
1994 IEEE Nonlinear Optics (1994) 358.
- 16) "Reflection Spectra of Dense Amorphous SiO₂ in the Vacuum-UV Region"
N. Kitamura, K. Fukumi, K. Kadono, H. Yamashita and K. Suito
Phys. Rev. B **50** (1994) 132.
- 17) "Far-Infrared Reflectivity Spectra of the Hydrogen-Bonded Ferroelectric KH₂PO₄ Measured by Synchrotron Radiation"
S. Shin, Y. Tezuka, S. Saito, Y. Chiba and M. Ishigame
J. Phys. Soc. Jpn. **63** (1994) 2612.
- 18) "Kinetic-Energy Release in the Dissociation of NO²⁺"
T. Masuoka
J. Chem. Phys. **100** (1994) 6422.
- 19) "Kinetic-Energy Release in the Dissociation of CO²⁺"
T. Masuoka
J. Chem. Phys. **101** (1994) 322.

- 20) "Dissociation Dynamics of CH_4^+ Core Ion in the 2A_1 State"
K. Furuya, K. Kimura, Y. Sakai, T. Takayanagi and N. Yonekura
J. Chem. Phys. **101** (1994) 2720.
- 21) "Time-Resolved Measurements of Excitation Spectra for Intrinsic Emission in Alkali Iodides"
T. Matsumoto, A. Miyamoto, K. Ichinose, A. Ohnishi, K. Kan'no and T. Hayashi
J. Lumi. **58** (1994) 335.
- 22) "Recombination Luminescence from Self-Trapped Excitons in BaFBr"
A. Ohnishi, K. Kan'no, Y. Iwabuchi and N. Mori
Nucl. Instrum. & Methods in Phys. Res. B **91** (1994) 210.
- 23) "Accumulated Photon Echoes Generated by Synchrotron Radiation"
H. Itoh, S. Nakanishi, M. Kawase, H. Fukuda, H. Nakatsuka and M. Kamada
Phys. Rev. A **50** (1994) 3312.
- 24) "Influence of Transition-Metal Type and Content on Local-Order Properties of $\text{Zn}_{1-x}\text{M}_x\text{S}$ ($M=\text{Mn,Fe,Co}$) Alloys Studied using XANES Spectroscopy"
W. F. Pong, R. A. Mayanovic, K. T. Wu, P. K. Tseng, B. A. Bunker, A. Hiraya and M. Watanabe
Phys. Rev. B **50** (1994) 7371.
- 25) "Beamsplitting and Polarization Properties of Cr/C Transmission Multilayers Close to the Carbon K-edge"
F. Schäfers, A. Furuzawa, K. Yamashita, M. Watanabe and J. H. Underwood
Phys. of X-ray Multilayer Structures **6** (1994) 155.
- 26) "Pressure Effect in Surface Phonon State of Microcrystalline NaCl"
T. Nanba, T. Matsuya and M. Motokawa
J. Phys. Soc. Jpn. **63** (1994) 3886.
- 27) "Optical Characteristics of SiO_2 formed by Plasma-Enhanced Chemical-Vapor Deposition of Tetraethoxysilane"
K. Ishii, Y. Ohki and H. Nishikawa
J. Appl. Phys. **76** (1994) 5418.
- 28) "Optical Measurements and Band Calculations of FeSi"
H. Ohta, S. Kimura, E. Kulatov, V. Halilov, T. Nanba, M. Motokawa, M. Sato and K. Nagasaka
J. Phys. Soc. Jpn. **63** (1994) 4206.

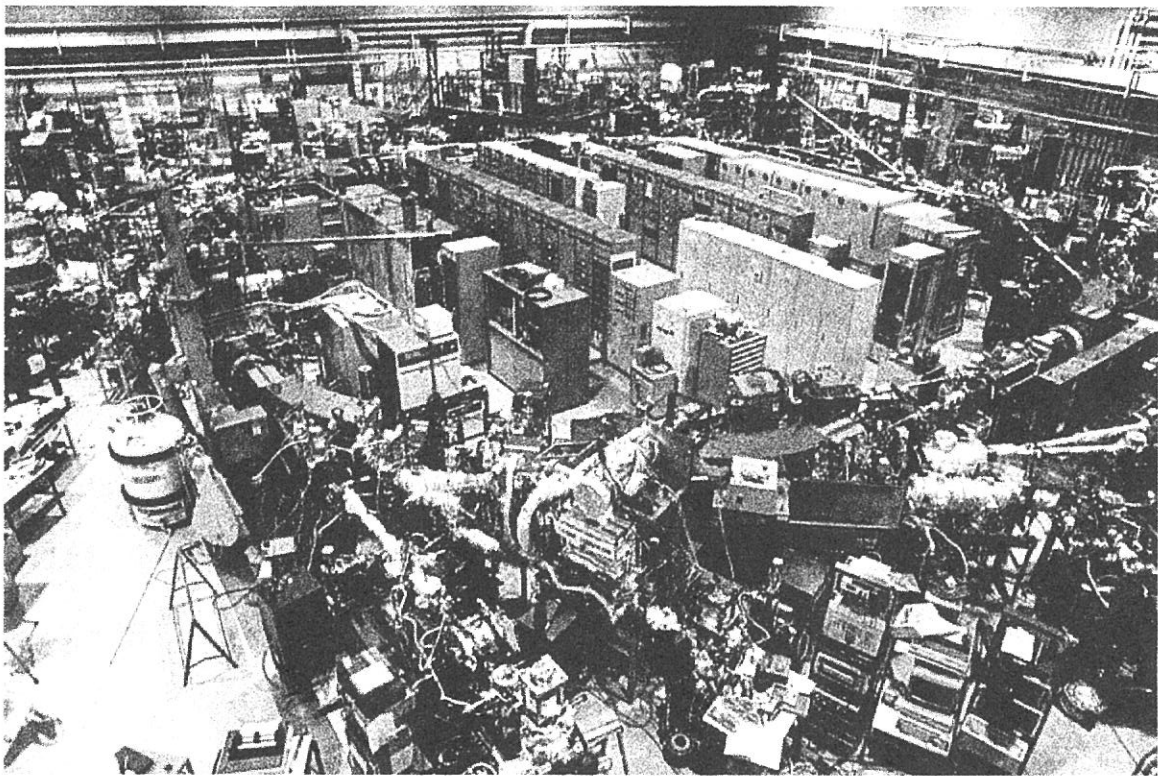
- 29) "Observation of Anisotropic Angular Distribution of Ionic Fragments in the Dissociation of CO^{2+} "
 T. Masuoka
 Phys. Rev. A **50** (1994) 2298.
- 30) "Ultraviolet Photoelectron Spectra of C_{78} and C_{96} "
 S. Hino, H. Takahashi, K. Iwasaki, T. Miyazaki, K. Kikuchi and Y. Achiba
 Chem. Phys. Lett. **230** (1994) 165.
- 31) "Synchrotron-Radiation Photoemission study of *In-situ* Synthesized DCNQI(*N,N*-Dicyanoquinonediimine)-Cu Salts"
 A. Tanaka, A. Chainani, T. Miura, T. Takahashi, T. Miyazaki, S. Hasegawa and T. Mori
 Solid State Commun. **93** (1995) 1.
- 32) "Intermolecular Energy-Band Dispersion in Oriented Thin Films of bis (1,2,5-thiadiazolo)-*p*-quinobis (1,3-dithiole) by Angle-Resolved Photoemission"
 S. Hasegawa, T. Mori, K. Imaeda, S. Tanaka, Y. Yamashita, H. Inokuchi, H. Fujimoto, K. Seki and N. Ueno
 J. Chem. Phys. **100** (1994) 6969.
- 33) "Electron Affinity of Single-Crystalline Chemical-Vapor-Deposited Diamond Studied by Ultraviolet Synchrotron Radiation"
 N. Eimori, Y. Mori, A. Hatta, T. Ito and A. Hiraki
 Jpn. J. Appl. Phys. **33** (1994) 6312.
- 34) "Metallic Na Formation in NaCl Crystals by Electron and VUV Photon Irradiation"
 S. Owaki, S. Koyama, M. Takahashi, T. Okada, R. Suzuki and M. Kamada
 EURODIM 94
- 35) "Platinum/Carbon Multilayer Reflectors for Soft-X-Ray Optics"
 G. S. Lodha, K. Yamashita, T. Suzuki, I. Hatsukade, K. Tamura, T. Ishigami, S. Takahama and Y. Namba
 Appl. Opt. **33** (1994) 5869.
- 36) "Core Electron Absorption Spectra of Films"
 I. Ouchi, I. Nakai, M. Kamada and S. Tanaka
 Prog. Polymer Phys. Jpn. **36** (1993) 413.
- 37) "Time Response of Sputtering of Excited-State Sodium Atoms from NaCl and NaF Irradiated with Synchrotron Radiation"
 M. Kamada and S. Hirose
 Nucl. Instrum. & Methods in Phys. Res. B **91** (1994) 619.

- 38) "Electronic Structure of Hole-Doped $\text{Sr}_{1+x}\text{La}_{1-x}\text{FeO}_4$ Studied by UPS and XAS"
T. Omata, K. Ueda H. Hosono, T. Miyazaki, S. Hasegawa, N. Ueda and
H. Kawazoe
Phys. Rev. B **49** (1994) 10202.
- 39) "Ultraviolet Photoelectron Spectra of C_{78} and C_{96} "
S. Hino, H. Takahashi, K. Iwasaki, T. Miyazaki, K. Kikuchi and Y. Achiba
Chem. Phys. Lett. **230**(1994) 165.
- 40) "Single- and Double-Photoionization Cross Section of Carbon Dioxide (CO_2) and
Ionic Fragmentation of CO_2^+ and CO_2^{2+} "
T. Masuoka
Phys. Rev. A **50** (1994) 3886.
- 41) "Low Temperature Growth of ZnTe by Synchrotron Radiation using Metalorganic
Sources"
M. Ikejiri, T. Ogata, H. Nishio and A. Yoshida
J. Vac. Sci. Technol. A **12** (1994) 278.
- 42) "Synchrotron Radiation Excited Growth of ZnTe using Metalorganic Sources"
T. Ogata, S. I. Gheyas, M. Ikejiri, H. Ogawa and M. Nishio
J. Cryst. Growth (1994) (in press).
- 43) "Construction of a System for Novel Low-temperature Growth of II-VI Compound
Semiconductors using Synchrotron Radiation"
T. Ogata, S. I. Gheyas, M. Ikejiri, H. Ogawa and M. Nishio
Rev. Sci. Instrum. **66** (1995) (in press).
- 44) "Observation of Micro-Macro Temporal Structure and Saturation Mechanism on the
UVSOR Free Electron Laser"
H. Hama, J. Yamazaki, T. Kinoshita, K. Kimura and G. Isoyama
Nucl. Instrum. & Methods in Phys. Res. A (1995) (in press).
- 45) "Optical Spectra of CeAs and LaAs"
S. Kimura, F. Arai, Y. Haga, T. Suzuki and M. Ikezawa
Physica B (1995) (in press).
- 46) "Base site of Magnesium Oxide Dispersed on Silica as Active Sites for CO
Photooxidation"
H. Yoshida, T. Tanaka, K. Nakatsuka, T. Funabiki and S. Yoshida
Proceedings of the international symposium on Acid-Base Catalysis II,
Sapporo, December 2-4, 1993, in Acid-Base Catalysis II, ed. H. Hattori, M.
Misono and Y. Ono, Kodansha
Elsevier, Tokyo, (1994) 473-478.

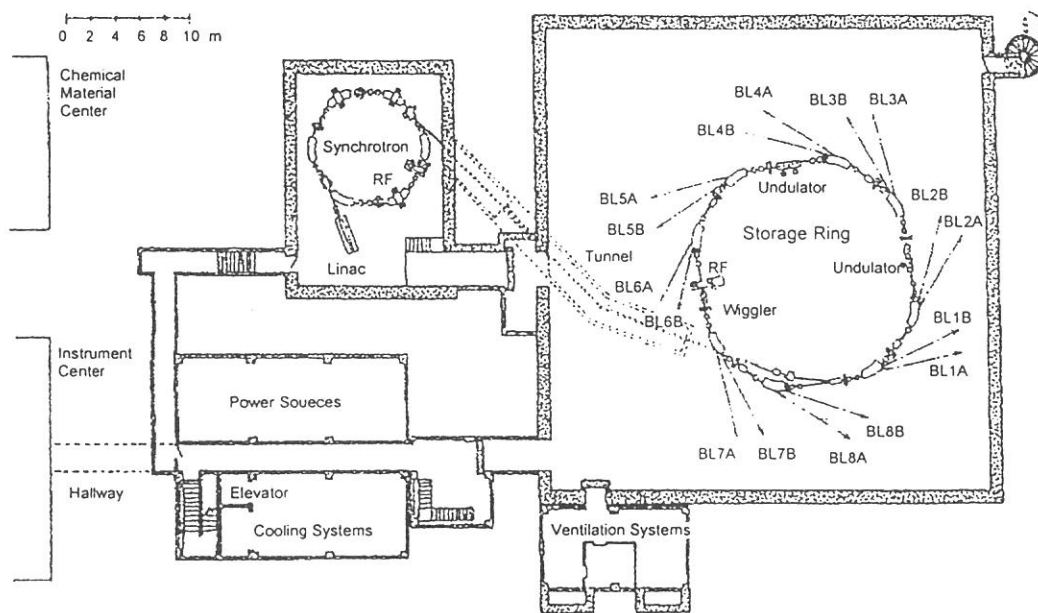
- 47) "Na K-Edge XAFS Study of Sodium Loaded on Alumina"
S. Hasegawa, M. Morooka, H. Aritani, H. Yoshida and T. Tanaka
Jpn. J. Appl. Phys. **32** (1993) 508.
- 48) "A XANES Study on the Dehydration Process of Magnesium Hydroxide"
T. Yoshida, T. Tanaka, H. Yoshida, S. Takenaka, T. Funabiki, S. Yoshida and
T. Murata
Physica B (1995) (in press).

in Japanese

- 1) "Far-Infrared Spectroscopic Study of Adsorbed Species on Surfaces"
T. Nanba
HYOMEN KAGAKU **15** (1994) 152.
- 2) "Intermolecular Energy-Band Dispersion of BTQBT Thin Films"
S. Hasegawa, N. Ueno and K. Seki
HOSYAKO **7** (1994) 119.
- 3) "Angle-Resolved Ultraviolet Photomission Studies of Functional Organic Molecular
Thin Films"
S. Hasegawa, H. Ishii and N. Ueno
HYOMEN KAGAKU **15** (1994) 575.
- 4) "Ion-Pair Formation from Superexcited Molecules"
K. Mitsuke
HOSYAKO **7** (1994) 309.
- 5) "Stimulated Ultraviolet Emission in BaF₂ Crystals under Core-Level Excitation"
H. Itoh and K. Itoh
OYOBUTURI **63** (1994) 721.

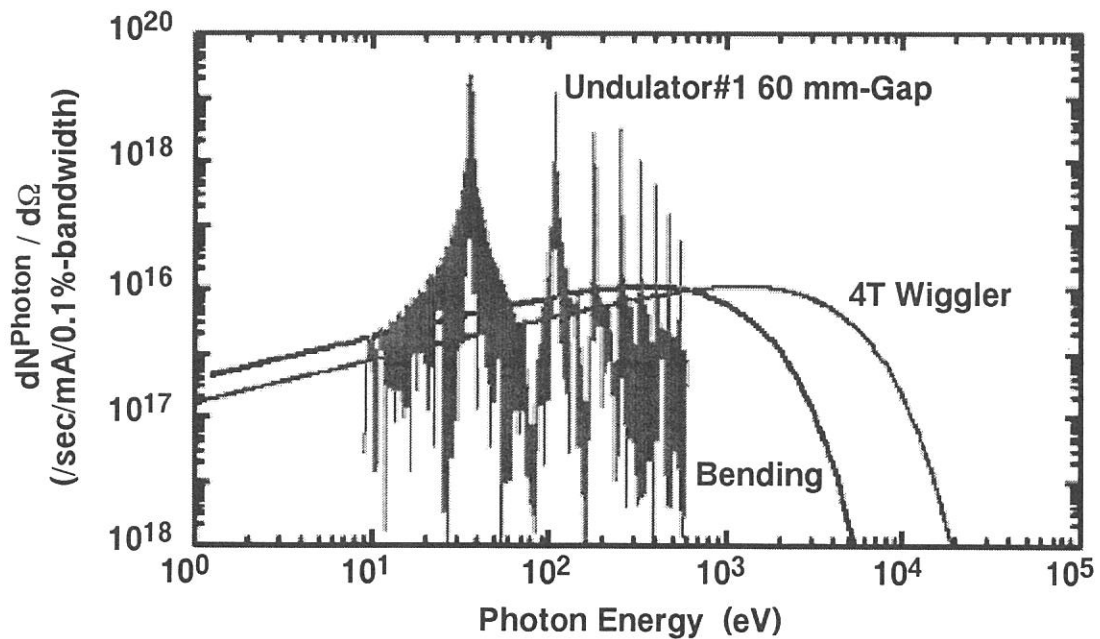
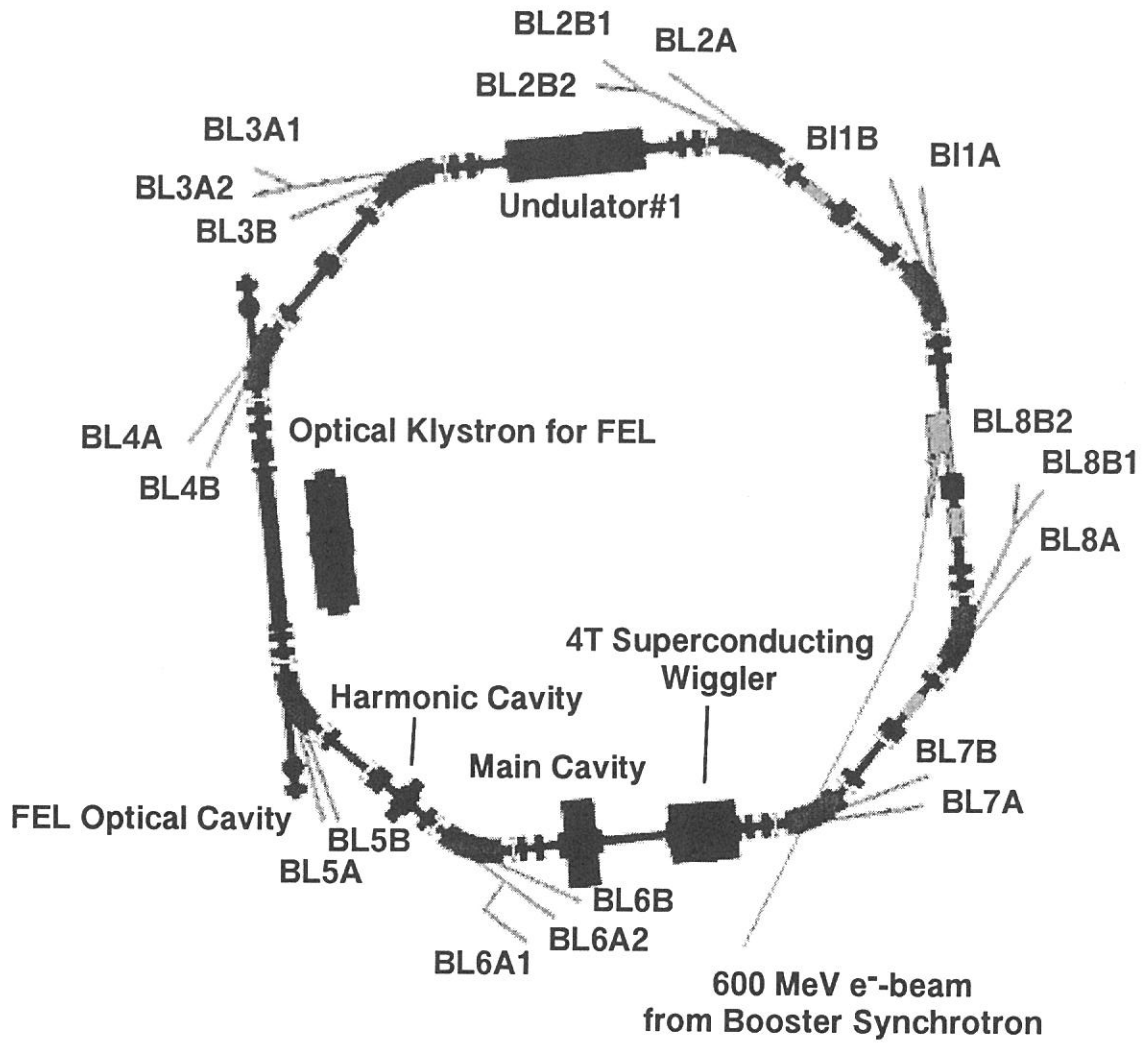


A picture of the experimental hall of the UVSOR facility.



Ground plan of the basement of the UVSOR facility.

The UVSOR 750 MeV Storage Ring



On-Axis Photon Intensity with 750 MeV-Electrons

Accelerator Complex

Injector Linac

Energy	15 MeV
Energy spread	~ 1.6 %
Frequency	S-band 2.856 GHz
Acceleration	$2\pi/3$ traveling wave
Length	2.5 m (from gun to exit)
Klystron power	~ 1.8 MW

Booster Synchrotron

Lattice type	FODO
Energy	600 MeV
Beam current	32 mA (8-bunch filled)
Circumference	26.6 m
Super cell	6
Bending radius	1.8 m
Betatron number	2.25 (horizontal) 1.25 (vertical)
Momentum compaction α	0.138
Harmonics	8
RF frequency	90.115 MHz
Repetition rate	2.6 Hz

Storage Ring

Lattice type	Chasman-Green
Energy	750 MeV
Critical energy	425 eV
Circumference	53.2 m
Super cell	4
Bending radius	2.2 m
Betatron tune	3.16 (horizontal) 2.64 (vertical)
Momentum compaction α	0.032
Harmonics	16
RF frequency	90.115 MHz
RF voltage	50 kV
Emittance	$1.15 \times 10^{-7} \mu\text{m rad}$ $1.15 \times 10^{-8} \mu\text{m rad}$
Beam size	0.39 mm (horizontal) 0.27 mm (vertical)
Bunch Length	170 ps (at zero current)
Beam current	Multi-bunch 200 mA Single-bunch 50 mA
Lifetime (Multi-bunch)	4 h at 200 mA 9 h at 100 mA

Additional equipments

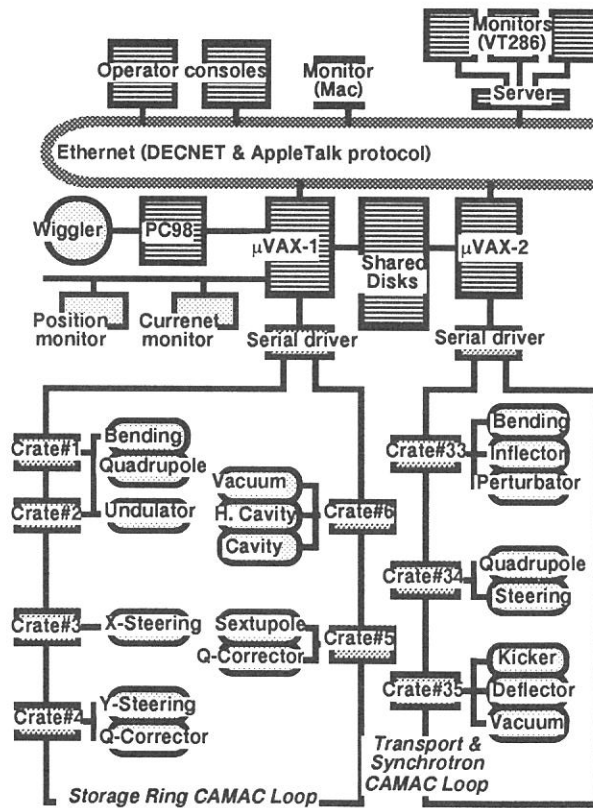
Higher-harmonic cavity	3 × 90.115MHz
Superconducting Wiggler	4T maximum
Undulator	for SR
Optical Klystron	for FEL

Control System

Preface: Based on Dual-host system with CAMAC loop and friendly man-machine interface

Architecture

CPU	2 μ-VAXs (3400)
OS	VMS
Connection	DECNET & Local Cluster
Operator console	2 VAX-Stations (DEC-Window)
Status monitors	VT286s + Macintoshes
Interface	CAMAC serial loop GPIB for beam monitors RS232C for host cpu of Wiggler
Language	Fortran, C, Pascal



Scheme of Accelerator Control System "UCOSS"

Beam Lines at UVSOR

Beam Line	Monochromator, Spectrometer	Wavelength Region	Acceptance Angle (mrad)		Experiment
			Horiz.	Vert.	
BL1A	Double Crystal	21 - 3 Å	4	1	Solid
BL1B	1-m Seya-Namioka	6500 - 300 Å	60	6	Solid
BL2A	1-m Seya-Namioka	4000 - 300 Å	40	6	Gas
BL2B1	2-m Grasshopper	600 - 15 Å	10	1.7	Solid, Surface & Gas
BL2B2	1-m Seya-Namioka	2000 - 300 Å	20	6	Gas
BL3A1	None (Filter, Mirror)		(U) 0.3	0.3	Solid & Irradiation
BL3A2	2.2-m Consant Deviation	1000 - 100 Å	10	4	Gas & Solid
	Grazing Incidence		(U) 0.3	0.3	
BL3B	3-m Normal Incidence	4000 - 300 Å	20	6	Gas
BL4A	None		6	6	Irradiation
BL4B	None		8.3	6	Irradiation
BL5A	None		(OK)		FEL
BL5B	Plane Grating	2000 - 20 Å	10	2.2	Calibration, Gas & Solid
BL6A1	Martin-Puplett	2000 - 30 μm	80	60	Solid
BL6A2	Plane Grating	6500 - 80 Å	10	6	Solid & Surface
BL6B	FT-IR	200 - 1.7 μm	70	25	Solid
BL7A	Double Crystal	15 - 8 Å	2	0.3	Solid
		15 - 2 Å	(W) 1	0.15	
BL7B	1-m Seya-Namioka	6500 - 300 Å	40	8	Solid
BL8A	None (Filter)		25	8	Irradiation, User's Instrum.
BL8B1	15-m Constant Deviation	400 - 20 Å	10	1.5	Gas & Solid
	Grazing Incidence				
BL8B2	Plane Grating	6500 - 80 Å	10	6	Solid

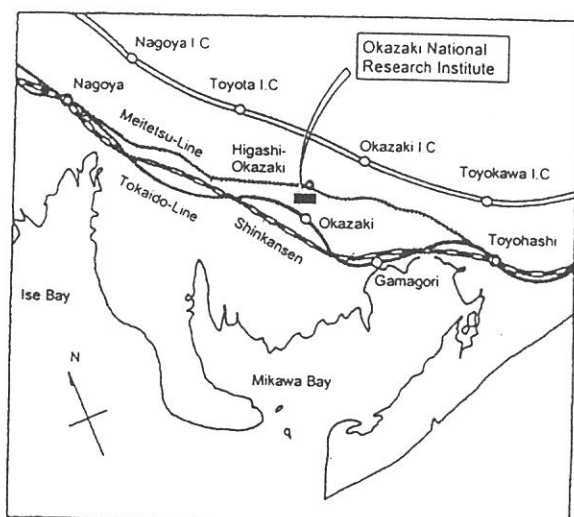
U: with an undulator

W: with a wiggler

OK: with an optical klystron

LOCATION

Ultraviolet Synchrotron Orbital Radiation (UVSOR) Facility, Institute for Molecular Science (IMS) is located at Okazaki. Okazaki (population 320,000) is 260 km southwest of Tokyo, and can be reached by train in about 3 hours from Tokyo via New Tokaido Line (Shinkansen) and Meitetsu Line.



ADDRESS

UVSOR Facility
Institute for Molecular Science
Myodaiji, Okazaki 444, JAPAN

Tel +81-564-55-7402 (Secretary, UVSOR)
+81-564-52-6101 (UVSOR)
Fax +81-564-54-7079 (UVSOR)
Telex 4537475 KOKKEN J (IMS)